# DSA8300 Digital Serial Analyzer Quick Start User Manual





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Tektronix, Inc. 14150 SW Karl Braun Drive P.O. Box 500 Beaverton, OR 97077 USA

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- Worldwide, visit www.tektronix.com to find contacts in your area.

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# **General safety summary**

Review the following safety precautions to avoid injury and prevent damage to this product or any products connected to it.

To avoid potential hazards, use this product only as specified.

Only qualified personnel should perform service procedures.

While using this product, you may need to access other parts of a larger system. Read the safety sections of the other component manuals for warnings and cautions related to operating the system.

#### To avoid fire or personal injury

Use proper power cord. Use only the power cord specified for this product and certified for the country of use.

**Connect and disconnect properly.** Do not connect or disconnect probes or test leads while they are connected to a voltage source.

**Ground the product.** This product is grounded through the grounding conductor of the power cord. To avoid electric shock, the grounding conductor must be connected to earth ground. Before making connections to the input or output terminals of the product, ensure that the product is properly grounded.

**Observe all terminal ratings.** To avoid fire or shock hazard, observe all ratings and markings on the product. Consult the product manual for further ratings information before making connections to the product.

The inputs are not rated for connection to mains or Category II, III, or IV circuits.

Do not apply a potential to any terminal, including the common terminal, that exceeds the maximum rating of that terminal.

**Power disconnect.** The power switch disconnects the product from the power source. See instructions for the location. Do not block the power switch; it must remain accessible to the user at all times.

Do not operate without covers. Do not operate this product with covers or panels removed.

**Do not operate with suspected failures.** If you suspect that there is damage to this product, have it inspected by qualified service personnel.

Avoid exposed circuitry. Do not touch exposed connections and components when power is present.

Use proper fuse. Use only the fuse type and rating specified for this product.

Wear eye protection. Wear eye protection if exposure to high-intensity rays or laser radiation exists.

Do not operate in wet/damp conditions.

Do not operate in an explosive atmosphere.

Keep product surfaces clean and dry.

**Provide proper ventilation.** Refer to the manual's installation instructions for details on installing the product so it has proper ventilation.

#### Terms in this manual

These terms may appear in this manual:



WARNING. Warning statements identify conditions or practices that could result in injury or loss of life.



CAUTION. Caution statements identify conditions or practices that could result in damage to this product or other property.

#### Symbols and terms on the product

These terms may appear on the product:

- DANGER indicates an injury hazard immediately accessible as you read the marking.
- WARNING indicates an injury hazard not immediately accessible as you read the marking.
- CAUTION indicates a hazard to property including the product.

The following symbol(s) may appear on the product:





Protective Ground High Voltage (Earth) Terminal





Mains Disconnected OFF (Power) ON (Power)



Standby

## **Compliance information**

This section lists the EMC (electromagnetic compliance), safety, and environmental standards with which the instrument complies.

### **EMC** compliance

#### EC declaration of conformity – EMC

Meets intent of Directive 2004/108/EC for Electromagnetic Compatibility. Compliance was demonstrated to the following specifications as listed in the Official Journal of the European Communities:

EN 61326-1:2006, EN 61326-2-1:2006. EMC requirements for electrical equipment for measurement, control, and laboratory use. <sup>1</sup> <sup>2</sup> <sup>3</sup> <sup>6</sup>

- CISPR 11:2003. Radiated and conducted emissions, Group 1, Class A
- IEC 61000-4-2:2001. Electrostatic discharge immunity
- IEC 61000-4-3:2002. RF electromagnetic field immunity 4
- IEC 61000-4-4:2004. Electrical fast transient / burst immunity
- IEC 61000-4-5:2001. Power line surge immunity
- IEC 61000-4-6:2003. Conducted RF immunity
- IEC 61000-4-11:2004. Voltage dips and interruptions immunity <sup>5</sup>

EN 61000-3-2:2006. AC power line harmonic emissions

EN 61000-3-3:1995. Voltage changes, fluctuations, and flicker

#### European contact.

Tektronix UK, Ltd. Western Peninsula Western Road Bracknell, RG12 1RF United Kingdom

- <sup>1</sup> This product is intended for use in nonresidential areas only. Use in residential areas may cause electromagnetic interference.
- <sup>2</sup> Emissions which exceed the levels required by this standard may occur when this equipment is connected to a test object.
- <sup>3</sup> To ensure compliance with the EMC standards listed here, use high quality shielded interface cables.
- <sup>4</sup> Horizontal timing susceptibility of the optical sampling modules and their internal clock recovery trigger signals usually increases the horizontal timing jitter when external electromagnetic fields are applied. For fields up to 3 V/m, the increase in the horizontal high-frequency RMS jitter is typically less than 3 ps RMS of jitter, added using the square-root-of-the-sum-of-the-squares method. For example, if an 80C01–CR operating in clock-recovery trigger mode exhibits 3.5 ps RMS of edge jitter, with no EMC field applied and for an ideal jitterless input, then for applied fields up to 3 V/m the edge jitter, degradation would typically result in a total RMS jitter of:

$$Jitter \ \le \ \sqrt{3.5 \ ps^{\ 2} \ + \ 3 \ ps^{\ 2}} \ = \ 4.61 \ ps$$

- <sup>5</sup> Performance Criterion C applied at the 70%/25 cycle Voltage-Dip and the 0%/250 cycle Voltage-Interruption test levels (IEC 61000-4-11). If the instrument powers down upon a voltage dip or interruption, it will take longer than ten seconds to reboot.
- <sup>6</sup> With an 80E01 Electrical Sampling module, up to 15 mV<sub>RMS</sub> random noise is allowed when the instrument is subjected to fields and signals as defined in the IEC 61000-4-3 and IEC 61000-4-6 tests.

#### Australia / New Zealand declaration of conformity - EMC

Complies with the EMC provision of the Radiocommunications Act per the following standard, in accordance with ACMA:

 CISPR 11:2003. Radiated and Conducted Emissions, Group 1, Class A, in accordance with EN 61326-1:2006 and EN 61326-2-1:2006.

### Safety compliance

#### EC declaration of conformity - low voltage

Compliance was demonstrated to the following specification as listed in the Official Journal of the European Communities:

Low Voltage Directive 2006/95/EC.

EN 61010-1: 2001. Safety requirements for electrical equipment for measurement control and laboratory use.

#### U.S. nationally recognized testing laboratory listing

UL61010-1, 2nd Edition. Safety requirements for electrical equipment for measurement, control, and laboratory use-Part 1.

#### **Canadian certification**

CAN/CSA-C22.2 No. 61010-1-2004. Safety requirements for electrical equipment for measurement, control, and laboratory use- Part 1

#### **Additional compliances**

■ IEC 61010-1: 2001. Safety requirements for electrical equipment for measurement, control, and laboratory use.

#### **Equipment type**

Test and measuring equipment.

#### Safety class

Class 1 - grounded product.

#### Pollution degree description

A measure of the contaminants that could occur in the environment around and within a product. Typically the internal environment inside a product is considered to be the same as the external. Products should be used only in the environment for which they are rated.

- Pollution Degree 1. No pollution or only dry, nonconductive pollution occurs. Products in this category are generally encapsulated, hermetically sealed, or located in clean rooms.
- Pollution Degree 2. Normally only dry, nonconductive pollution occurs. Occasionally a temporary conductivity that is caused by condensation must be expected. This location is a typical office/home environment. Temporary condensation occurs only when the product is out of service.
- Pollution Degree 3. Conductive pollution, or dry, nonconductive pollution that becomes conductive due to condensation. These are sheltered locations where neither temperature nor humidity is controlled. The area is protected from direct sunshine, rain, or direct wind.
- Pollution Degree 4. Pollution that generates persistent conductivity through conductive dust, rain, or snow. Typical outdoor locations.

#### **Pollution degree**

Pollution Degree 2 (as defined in IEC 61010-1). Note: Rated for indoor use only.

#### Installation (overvoltage) category descriptions

Terminals on this product may have different installation (overvoltage) category designations. The installation categories are:

- Measurement Category IV. For measurements performed at the source of low-voltage installation.
- Measurement Category III. For measurements performed in the building installation.
- Measurement Category II. For measurements performed on circuits directly connected to the low-voltage installation.
- Measurement Category I. For measurements performed on circuits not directly connected to MAINS.

#### **Overvoltage category**

Overvoltage Category II (as defined in IEC 61010-1)

### **Environmental considerations**

This section provides information about the environmental impact of the product.

#### Product end-of-life handling

Observe the following guidelines when recycling an instrument or component:

**Equipment recycling.** Production of this equipment required the extraction and use of natural resources. The equipment may contain substances that could be harmful to the environment or human health if improperly handled at the product's end of life. In order to avoid release of such substances into the environment and to reduce the use of natural resources, we encourage you to recycle this product in an appropriate system that will ensure that most of the materials are reused or recycled appropriately.



This symbol indicates that this product complies with the applicable European Union requirements according to Directives 2002/96/EC and 2006/66/EC on waste electrical and electronic equipment (WEEE) and batteries. For information about recycling options, check the Support/Service section of the Tektronix Web site (www.tektronix.com).

**Perchlorate materials.** This product contains one or more type CR lithium batteries. According to the state of California, CR lithium batteries are classified as perchlorate materials and require special handling. See www.dtsc.ca.gov/hazardouswaste/perchlorate for additional information.

#### **Restriction of hazardous substances**

This product is classified as an industrial monitoring and control instrument, and is not required to comply with the substance restrictions of the recast RoHS Directive 2011/65/EU until July 22, 2017.

# **Preface**

### **Documentation**

This manual describes the installation and operation of the DSA8300 Digital Serial Analyzer including basic operation and concepts. For more detailed information, see the online help on your instrument.

NOTE. The screen images in this manual may differ slightly from other versions of product software.

Additional information is available through a variety of sources. The following table points to the location of different types of information available for this product.

Type of information	Location
Unpacking, installation, operation and overviews	Quick Start User Manual
In-depth operation, UI help, programming help	Instrument online help
Performance verification and specifications	Product documentation CD
Product software	Product software CD
	www.tektronix.com/software
Service	Service manual
PDF files of instrument and modules manuals	Product software CD
	www.tektronix.com/manuals

### Conventions used in this manual

The following icons may be used in this manual.

Rear panel power

Front panel power

PS2

USB





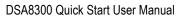








Connect power Network



# **Key features**

The DSA8300 is a state-of-the-art equivalent time sampling oscilloscope that provides the highest fidelity measurement and analysis capabilities for communications signal analysis, serial data network analysis, and serial data link analysis applications.

#### Highest fidelity signal capture

- Very Low Time-base Jitter:
  - = 425 fs typical on up to 8 simultaneously acquired channels
  - = <100 fs typical on up to 6 channels with 82A04B phase reference module
- Best vertical resolution (16 bit A/D):
  - = Electrical resolution: <20 μV LSB (for 1 V full range)
  - Optical resolution depends on the dynamic range of the optical module ranges from <20 nW for the 80C07B (1 mW full range) to <0.6 μW for the 80C10B (30 mW full range)</li>

#### **Flexible configurations**

- The DSA8300 supports up to 8 simultaneously acquired signals
- A wide variety of optical, electrical, and accessory modules to support your specific testing requirements
- Use the new Change/View Module Config function to install or remove modules without powering down the instrument

#### **Optical modules**

- Fully integrated optical modules that support all standard optical data rates from 155 Mb/s to 100 Gb/s
- Certified optical reference receivers support specified requirements for standards-mandated compliance testing
- Optical bandwidths to >80 GHz
- High optical sensitivity and low noise as well as the wide dynamic range of the optical sampling modules allows accurate testing and characterization of short-reach to long-haul optical communications standards
- Fully calibrated clock recovery solutions; no need to manually calibrate for data pick-off losses
- Calibrated extinction ratio measurements ensure repeatability of extinction ratio measurements to <0.5 dB among systems with modules with this factory calibration option

#### **Electrical modules**

- Electrical bandwidths to >70 GHz
- Very low-noise electrical samplers (280 µV at 20 GHz, 450 µV at 60 GHz, typical)
- Selectable bandwidths (module 80E07B, 80E08B, 80E09B, 80E10B, 80E11, 80E11X1) allow the user to trade-off sampler bandwidth and noise for optimal data acquisition performance

- Remote samplers (module 80E07B, 80E08B, 80E09B, 80E10B, 80E11, 80E11X1) or compact sampling extender module cables support minimal signal degradation by locating the sampler in close proximity to the device under test
- World's highest-performance integrated TDR (10 ps typical step rise time) supports exceptional impedance discontinuity characterization and high dynamic range for S-parameter measurements to 50 GHz

#### Analysis

- Standard Analysis Capabilities:
  - Complete suite of over 120 automated measurements for NRZ, RZ, and Pulse signal types
  - Automated mask testing with over 80 industry-standard masks. New masks can be imported into the DSA8300 to support new emerging standards. In addition, users can define their own masks for automated mask testing
- Vertical and Horizontal histograms for statistical analysis of acquired waveforms
- Vertical, Horizontal, and Waveform cursors (with measurements)
- Jitter, Noise, BER, and Serial Data Link Analysis is provided through the 80SJNB Basic and Advanced software application options
- Advanced TDR Analysis, S-parameter measurements, Simulation Model Extraction, and Serial Link Simulation capabilities are provided through the IConnect® Software application options

#### High test throughput

- High Sample Acquisition Rate up to 300 kS/s per channel
- Efficient Programmatic Interface (IEEE-488, Ethernet, or local processor access) enable High Test Throughput

# Install your instrument

Unpack the instrument and check that you received all items listed as Standard Accessories. Recommended accessories and probes, instrument options, and upgrades are listed in the online help. Check the Tektronix Web site (www.tektronix.com) for the most current information.

### **Standard accessories**

Accessory	Tektronix part number
DSA8300 Digital Serial Analyzer Quick Start User Manual	071-2897-XX
Certificate of Traceable Calibration for product at initial shipment	Not orderable
Business reply card	Not orderable
Keyboard	119-7083-00
Mouse	119-7054-00
Instrument front cover	200-4519-00
Accessory pouch	016-1441-00
Touch screen styluses (2)	119-6107-00
ESD wrist strap with 6 foot coiled cord	006-3415-04
DSA8300 Product Documentation Kit (CD)	020-3082-XX
DSA8300 Online Help (part of application software)	Not orderable
DSA8300 Programmer Online Manual (part of application software)	Not orderable
DSA8300 Product Software Install Kit	020-3088-XX
DSA8300 Operating System Restore Kit	020-3089-XX
Power cord	Type dependent on selection during order placement
VGA female to DVI male adapter	013-0347-00

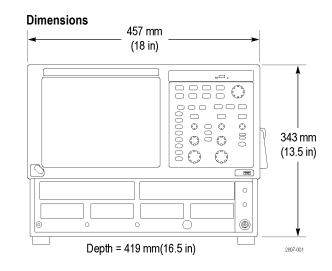
### **Operating considerations**

The following information lists the specifications related to the operation of the mainframe. Refer to the DSA8300 Digital Serial Analyzer Specifications and Performance Verification Manual for a complete list of specifications.

#### Mechanical

#### **Clearance requirements**

- Top, Front, and Rear: 0 mm (0 in)
- Sides: 51 mm (2 in)
- Bottom: 19 mm (0.75 in)



Weight	19.5 kg (43.0 lb.). This does not include any accessories or modules.
Orientation	Place the instrument on a cart or bench. The instrument should rest on its bottom or rear feet. The front feet fold down to angle the instrument.
Rack mounting	An optional rack mounting kit (Option 1R) is available.
Environmental	
Temperature	10 °C to +40 °C
Relative humidity	20% to 80%, with a maximum wet bulb temperature of 29 $^\circ\mathrm{C}$ at or below +40 $^\circ\mathrm{C}$
Altitude	3,000 m (9,843 ft.)

Power supply	
Source voltage and Frequency	100 - 240 $V_{\text{RMS}}$ ±10%, 50 - 60 Hz or 115 $V_{\text{RMS}}$ ±10%, 400 Hz
Power Consumption	600 watts maximum Typically, 240 watts (fully loaded); 160 watts (mainframe with no modules)
Fuses	3AG, 8 A, 250 V, 15 second, ceramic fuse, Tektronix part number 159-0046-XX
	or
	6.3 A, 250 V, fast blow (European), Tektronix part number 159-0381-XX

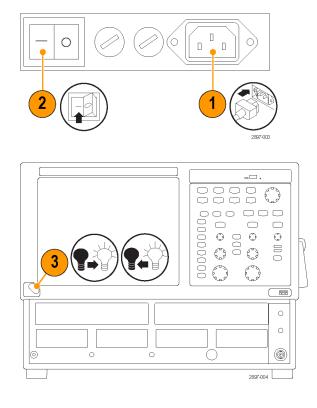
#### Input connectors

Trigger Direct Input range	$\pm$ 1.5 V (DC + peak AC) maximum input voltage
Trigger Prescaled Input absolute maximum input (typical)	±1.1 V <sub>p-p</sub>
External 10 MHz Reference Input	500 mV_{p-p} to 5 V_{p-p} AC coupled into 1 k\Omega, ±5 V maximum

## Powering the instrument on and off

- 1. Insert AC power cord.
- 2. Toggle the mains switch to on.

**3.** Use the front panel power button to switch the instrument on and off.

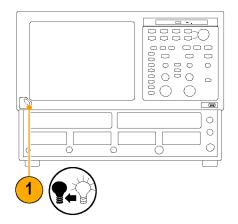


**CAUTION.** To prevent damaging the modules, do not install or remove any modules while the instrument is powered on.

### Adding a second monitor

You can add a second monitor to provide two screens for viewing instrument applications or readouts.

1. Power off the instrument.



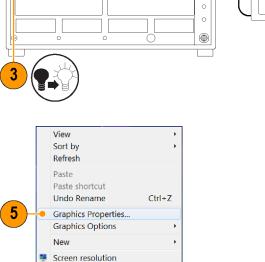
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2. Connect a video cable (not supplied) from the DVI-I out video port on the back of the instrument to the DVI-I port on the external monitor.

NOTE. Use a DVI-I to SVGA adapter (not supplied) to connect to SVGA monitors.

- 3. Power on the instrument.
- 4. Power on the external monitor. The instrument detects the external monitor and displays the contents of the instrument screen.

5. Move the cursor to a blank area of the screen, right-click the mouse to open the context menu, and select Graphics Properties.



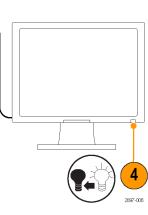
🔹 Gadgets 2

Personalize

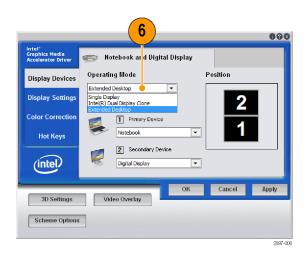
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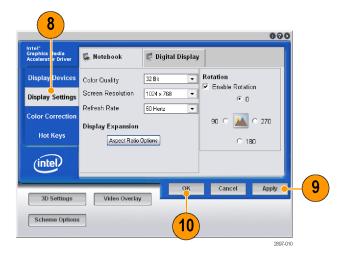
6. Select the display mode from the **Operating Mode** list.



 If using an extended desktop, click the external monitor 2 box in the **Position** pane and drag the monitor to the position that relates to the physical position of monitor 2 in relation to monitor 1.



- Click the Display Settings tab, click the Digital Display tab, and use the fields to set the monitor 2 screen characteristics.
- Click Apply. The instrument makes the selected changes and then prompts you to keep the changes (if OK) or to Cancel the settings and return to the previous settings. If the new settings are correct, click OK. You have about 15 seconds before the instrument automatically returns to the previous display settings.
- **10.** Click **OK** to close the Intel Graphics Media Accelerator Driver window.



# Installing modules

This section describes how to install and remove modules, as well as how to move modules while the instrument is powered on.

## Typical module installations

The following are some typical module installations illustrating the interaction between large compartment channels and small compartment channels.

**NOTE.** A large compartment module that only derives power from the compartment does not use any small compartment input channels.

Eight channels: No large and four small modules	CH	11 Module n	ot installed		CH	13 Module n	ot installed	k
	CH 1	CH 2	CH 3	CH 4	CH 5	CH 6	CH 7	CH 8
Six channels: Two large modules and two small modules		CH1 modul	e installed			CH3 module	e installed	
	CH 1 N.A.	CH 2 N.A.	CH 3 N.A.	CH 4 N.A.	CH 5	CH 6	CH 7	CH 8
Seven channels: One large module, installed in CH3 compartment, and three small	СН	1 module n	ot installed			CH3 module	e installed	
modules	CH 1	CH 2	CH 3 N.A.	CH 4 N.A.	CH 5	CH 6	CH 7	CH 8
Seven channels: One large module, installed in CH1 compartment, and three small modules		CH1 module	e installed		CH	13 module n	ot installed	ł
	CH 1 N.A.	CH 2 N.A.	CH 3	CH 4	CH 5	CH 6	CH 7	CH 8

### Install a module

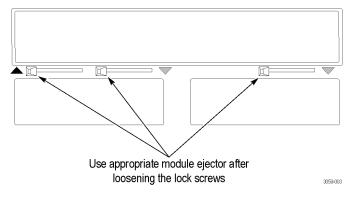
- 1. Connect an antistatic wrist strap to the instrument front-panel ground connection. Place the strap on your wrist.
- 2. For optical modules, turn the module lock screws counterclockwise to rotate the retaining tabs to a vertical position before inserting the module.
- 3. Use the power cycle that is appropriate for your instrument:
  - DSA8300 instruments with TekScope application version 6.1.X and greater: Click Tools > View/Change Module Config and follow the on-screen instructions. (See page 11, Powered-on module configuration.)
  - Legacy instruments and DSA8300 with TekScope application version 6.0.X: Power off the instrument using the front-panel On/Standby button.
- 4. Push the module into a compartment, using firm pressure. When the module is seated, turn the lock screw(s) clockwise to tighten the module in the slot.
- 5. Power on the instrument (legacy instruments or DSA8300 with 6.0.X software) or complete the View/Change Module Config process (software version 6.1.X and later). Let the instrument warm up for 20 minutes.

**NOTE.** The warm-up cycle is not required if you installed the module using the View/Change Module Config function (software version 6.1.X and later).

6. In the TekScope application, click Utilities > Compensate and run a compensation on the newly-installed module. You must also run a compensation if a module is moved from one slot to another, or an extender is installed, changed, or removed from a module.

### Remove a module

- 1. Connect an antistatic wrist strap to the instrument front-panel ground connection. Place the strap on your wrist.
- 2. Use the power cycle that is appropriate for your instrument:
  - DSA8300 instruments with TekScope application version 6.1.X and greater: Click Tools > View/Change Module Config and follow the on-screen instructions. (See page 11, Powered-on module configuration.)
  - Legacy instruments and DSA8300 with TekScope application version 6.0.X: Power off the instrument using the front-panel On/Standby switch.
- 3. Turn lock screw(s) counterclockwise until loose or they stop turning.
- 4. Push the appropriate ejector lever (as indicated by the up or down arrow near each lever) to the right to disconnect the module.



5. Pull the module out of the slot.

### Powered-on module configuration

The View/Change Module Config function lets you remove, install, or move modules without powering down the mainframe.



**CAUTION.** Installing or changing modules when powered on requires DSA8300 TekScope software version **6.1.X** or greater. For TekScope software versions earlier than 6.1.X, always power off the mainframe to remove or install modules. Failure to do so may result in damage to the module or mainframe. Download the latest DSA8300 software from www.tek.com/software.

 Select Utilities > View/Change Module Config to open the module configuration dialog box.

	80C01-C B01045		En	npty
En	npty	Empty	80E04 B011171	80E04 B011148

- Click on all module slots that you want to change. This includes slots from which to remove a module and slots in which to install a module.
- 3. Click Start.
- 4. The instrument notifies you when you can remove or install a module. Remove or install modules only from the indicated slots. Wear an antistatic strap when handling modules.
- Click Finish. The instrument notifies you when the selected modules are ready to use.
- 6. Close the dialog box.
- Select Utilities > Compensation and run a compensation on each channel of all newly installed modules. All newly installed modules require compensation, even if they were moved from one slot to another.

	80C01-CR		
	B010457	Empty	
Empty	Slot selected for reconfiguration	80E04 8011171 Slot selected for reconfiguration	80E04 B011148
		Start	

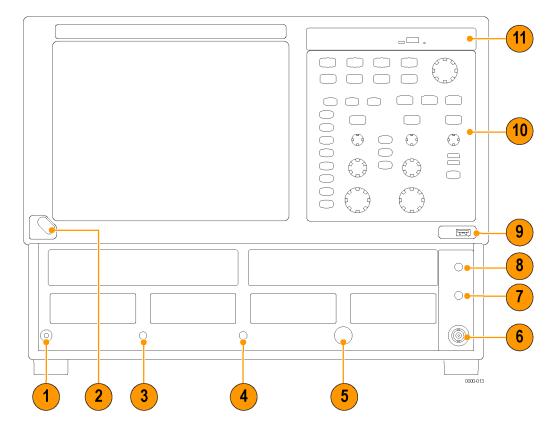
View/Change Module Config	
Reconfiguring Slots - In Progress	
80C01-CR B010457	Module may now be installed
Module may now be installed installed	Module may now be removed/installed B011148
Remove/install desired modules in selected slots then click Finis	sh Finish Close

80C01-CR 8010457		Em	pty	
Empty		Empty	80E04 B010888	80E04 B011148

# Getting acquainted with your instrument

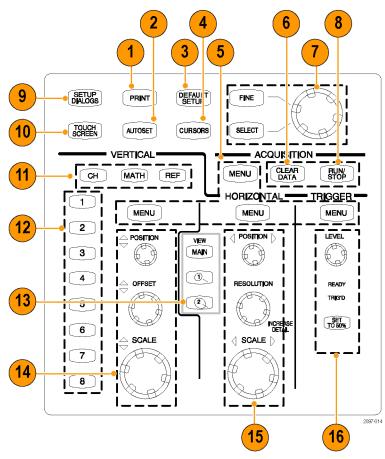
## Front panel

The front panel of your instrument gives you access to the module compartments and the control panel.



- **1.** Antistatic connection terminal (1 M $\Omega$ ).
- 2. On/Off switch.
- 3. Clock Input/Prescale Trigger input.
- 4. Trigger direct input.
- 5. Trigger probe power.
- 6. External 10 MHz reference input.
- 7. DC calibration output.
- 8. TDR Clock Out signal.
- 9. USB port(s).
- 10. Control panel.
- 11. DVD-ROM/CD-RW drive.

## **Control panel**

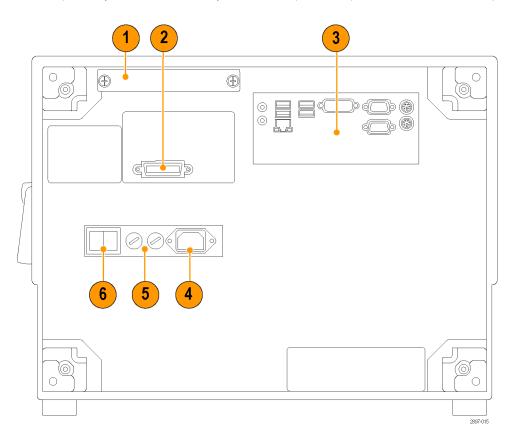


- 1. Access print dialog box for printing the display.
- 2. Optimize instrument settings for the selected channel to automatically display a waveform.
- 3. Quickly return the instrument to default control settings.
- 4. Display measurement cursors and assigns the knob and SELECT buttons to control them.
- 5. Menu buttons quickly access the setup dialog box for more detailed setup.
- 6. Clear all data and measurement results.
- 7. Adjust most control fields in setup dialogs. Push the SELECT button to select the active cursor (when cursors are enabled). Push the FINE button to toggle between normal and fine adjustment.
- 8. Start and stop acquisition.
- 9. Display the Setup dialog box for comprehensive setup of the instrument.
- 10. Toggle the touch screen on and off. Use the touch screen to control UI when you have not installed a mouse.
- 11. Select a waveform type (Channel, Reference, or Math) to display or adjust on screen (selected button lights).
- **12.** Push a channel button to select and display a waveform for that channel. A lit button indicates selected and displayed waveforms for that channel. An unlit button indicates that the channel is not selected.

- **13.** Select among displayed timebase views or display and select a magnified timebase view. Push the selected view to turn it off (except main, which is always on).
- 14. Vertically scale, position, and offset selected waveform.
- 15. Horizontally scale, position, and set record length of selected waveform.
- 16. Set trigger level (applies only to Trigger Direct Input) and use lights to monitor trigger state.

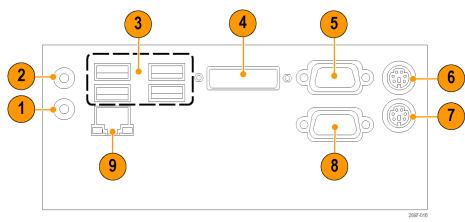
### **Rear panel**

The rear panel of your instrument allows you access to input and output connectors and the AC input.

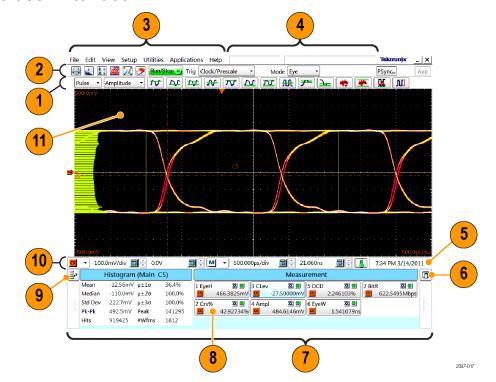


- 1. Removable hard drive.
- GPIB port. The instrument is factory set to be a talk/listen device, allowing you to control the instrument via the GPIB port. You can change the instrument to be a GPIB controller, allowing you to control other devices via the GPIB port, or set the instrument to be off bus. Refer to the Programmer Manual installed on the instrument.
- 3. Computer I/O panel. (See page 16, Computer I/O panel.)
- **4.** AC input.
- 5. Fuses.
- 6. Mains power switch.

# Computer I/O panel



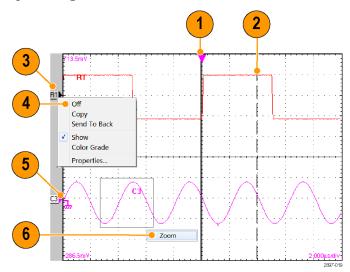
1. Audio line out	2. Mic input	3. USB ports
4. DVI-I video out for dual-monitor display	5. COM1	6. PS2 (keyboard)
7. PS2 (mouse)	8. COM2	9. LAN



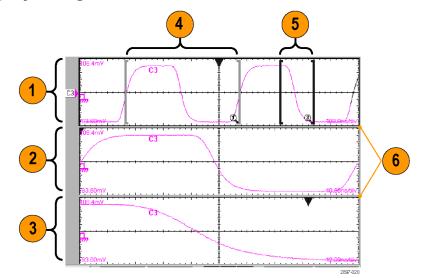
#### The user interface

- 1. Measurements Bar. Access to automated measurements by signal type and category; click measurement buttons to measure the selected waveform.
- 2. Tool Bar. Access to key features including printing, setup dialogs, math waveform setup, waveform database, autoset, clear data, acquisition mode, triggering, and applications.
- 3. Menu Bar. Access to data I/O, printing online help system, and setup functions.
- 4. Status Bar. Waveform count and trigger/acquisition status.
- 5. System Time/Date and compensation status.
- 6. Readout Docking. Select to undock the readout area from the application.
- 7. Readout area. Displays waveform and measurement details. Use the arrow buttons at each end to scroll the contents.
- 8. Readout. Right click on a readout to display a context menu for additional settings for that readout category.
- 9. Readout Enable. Toggles the readout type (cursor, histogram, mask, measurement, and waveform) on or off.
- 10. Controls Bar. Click to select a waveform (channel, math, or reference), as well as quick access to scale, offset, and position controls for adjustment.
- 11. Display. Contains live, reference, and math waveforms, and histograms, cursors and test masks when enabled.

### Display - single waveform view



- 1. Drag the Horizontal Reference to move the point around which the horizontal scaling expands and contracts the waveforms.
- 2. Drag cursors to measure waveforms on screen.
- 3. Drag the waveform icon vertically to position waveform.
- 4. Right-click on a waveform or its icon to open the context menu with setup controls and properties.
- 5. Drag ground reference icon to add offset to a waveform.
- 6. Drag across the waveform area to horizontally zoom the boxed waveform segment to full screen width.



## Display - magnified waveform views

- 1. MAIN View.
- 2. Mag1 View.
- 3. Mag2 View.
- 4. Drag the markers to enclose the portion of waveform to appear in Mag1 View.
- 5. Drag the markers to enclose the portion of waveform to appear in Mag2 View.
- 6. Drag the border between graticules to vertically size Main, Mag1, and Mag2 Views.

### Accessing online help

In-depth information about all the features of your instrument is available in the online help.

Position the mouse cursor on a control, File Edit View Setup Utilities Applicati such as a menu name, a menu item, toolbar button, or toolbar readout. The help system ± Run/Stop displays a short definition or description (tooltips) of the control. ĴŪĴ Pulse Amplitude Ŧ Ŧ High For in-depth, contextual overviews, most dialog boxes have a Help button. Click Advanced Trigger Setup... the button to open the help system for information on that dialog box. Help Select Help > Help Contents and Index to Help open the overall help system. Help Contents and Index Getting Started Guide Measurements Center Measurements Reference

> Programmer Guide About DSA8300

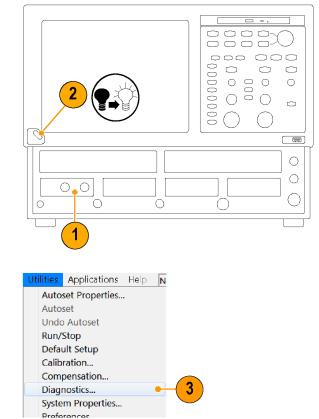
Tric

# Inspect your instrument

Use the following procedure to verify the functionality of your instrument. For a complete performance verification, see the DSA8300 Digital Serial Analyzer Performance Verification and Specifications Manual, which can be downloaded from the Tektronix Web site.

# Verify internal diagnostics pass

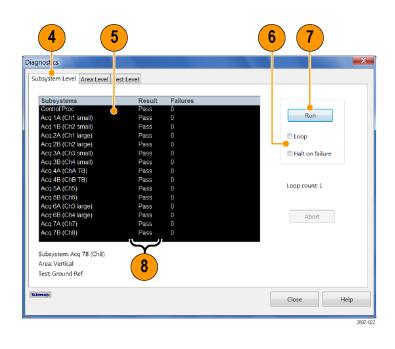
- 1. Install all modules to be diagnosed.
- **2.** Power on the instrument and wait 20 minutes for the warm-up period.



2897-021b

3. Select Utilities > Diagnostics.

- 4. Select the Subsystem Level tab.
- 5. Select all the entries by clicking the first entry **Control Proc** and dragging down to select the rest. All entries should be highlighted.
- 6. Verify that the Loop and Halt on Failure boxes are unchecked.
- 7. Click Run.
- 8. Verify that all tests display **Pass** in the Status column when the diagnostics complete. If diagnostic failures occur, contact your local Tektronix service center.



# **Optimizing measurement accuracy**

The instrument provides several utilities that optimize measurement accuracy:

- Signal path compensation (SPC) configures signal paths to improve measurement accuracy at the current ambient temperature.
- Dark-level compensation maximizes the accuracy of extinction ratio and other optical measurements
- User Wavelength Gain compensation optimizes an optical channel for a custom input signal
- Differential Channel Alignment application aligns input channels and TDR steps on supported electrical modules

### Signal path compensation

Signal path compensation (SPC) configures the instrument and module signal paths to make accurate measurements at the current ambient temperature.

You should run a SPC:

- After adding a module to the instrument
- After adding or removing an extender cable from a module.
- After moving a module to another slot.
- The ambient temperature has changed more than 5 °C since the last signal path compensation.
- When making measurements at vertical scale settings less than or equal to 5 mV/div. Perform the signal path compensation once a week under these conditions. Failure to do so may result in the instrument not meeting warranted performance levels at these volts/div settings.

NOTE. You must save the compensation results or they will be lost when the instrument is powered down.

- 1. Install all modules to be compensated. (See page 9, *Installing modules*.)
- Install all terminations and dust covers. Failure to install the 50 Ω terminations on electrical inputs can cause erroneous compensation failures or results.
- 3. If you powered off the instrument to change module configuration, power on the instrument and **wait 20 minutes** for the warm-up period.

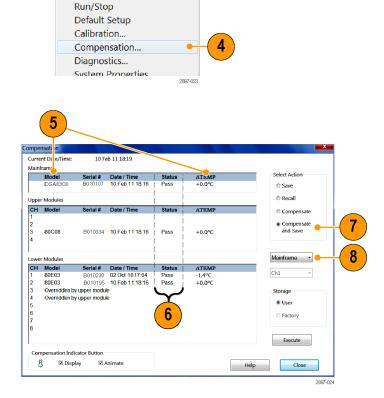
3	

4. Select Utilities > Compensation

- 5. Verify that the main instrument (mainframe) and all installed modules are listed. The temperature change from the last compensation is also listed.
- Check that the Status for all items to compensate changes from Warm Up to Pass, Fail, or Comp Req'd.
- 7. Select Compensate and Save (default).
- **8.** Select the item on which to run compensation:
- Mainframe (default selection) to compensate just the main instrument
- All modules to compensate all installed module channels
- Module to compensate specified channels of the selected module

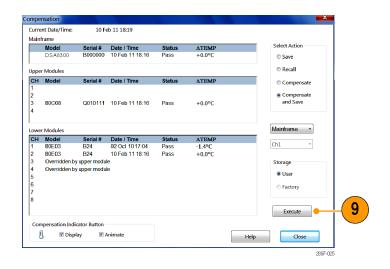
#### 9. Click Execute.

Follow the on-screen instructions regarding signal and trigger inputs and terminations; be sure to follow electrostatic handling precautions (see the user information for your sampling module) when following these instructions.



Setup Utilities Applications Help Autoset Properties...

> Autoset Undo Autoset



**10.** Verify that the compensation routines pass.

If the status is **Fail**, run the compensation again. If **Fail** status continues, the module or main instrument may need service.

 Use the Compensation Indicator Button to display or hide the compensation indicator on the main display. Green means that all modules have been successfully compensated. Yellow means that the instrument has not competed its 20 minute warm-up period. Red means that one or more modules require compensation.

Model       Serial #       Date / Time       Status       ATEMP         DSA8300       B000000       10 Feb 1118:16       Pass       +0.0°C       © Recall         CH       Model       Serial #       Date / Time       Status       ATEMP       © Compens         3       80C08       Q010111       10 Feb 1118:16       Pass       +0.0°C       @ Compens         4	Mainf	nt Date/Time:	10 Fe	b 11 18:19				
Upper Modules Upper Modules Upper Modules Upper Modules UCMM Model Serial # Date / Time Status ATEMP Compensation CH Model Serial # Date / Time Status ATEMP COmpensation Indicator Button B @ Compensation Indicator Button B @ Display @ Animate Compensation Indicator Button Compensation Indicator Button B @ Display @ Animate Compensation Indicator Button B @ Display @			Serial #	Date / Time	Status	ΔΤΕΜΡ		Select Action
Opper Housins       Compensation         1       2         3       800:08         4       Compensation         4       Compensation         1       10 Feb 11 18:16         2       Pass         4       Compensation         4       Compensation         4       Compensation         5       Compensation         6       Serial #       Date / Time         8       Status       ATEMP         1       80E03       B24       02 Oct 1017.04         9       B24       02 Oct 1017.04       Pass         4       Overridden by upper module       Ch1         5       Storage       ® User         6       Compensation Indicator Button       Factory         8       Compensation Indicator Button       Help         Class       Class       Class         5       Opensation       Status         6       Status       Compensation Indicator Button         9       It pass       Help       Class         5       Compensation Indicator Button       Status       Help       Class		DSA8300	B000000	10 Feb 11 18:16	Pass	+0.0°C		© Save
1       2         3       80C08       Q010111       10 Feb 1118:16       Pass       +0.0°C         4       4       0.000       B0203       B24       0.2 Oct 1017/04       Pass       -1.4°C         2       80E03       B24       10 Feb 1118:16       Pass       -1.4°C       Oct 1017/04         2       80E03       B24       10 Feb 1118:16       Pass       +0.0°C       Storage         3       Overridden by upper module       6       -1.4°C       Storage       © Lorer         6       7       7       7       -1.4°C       -1.4°C       Storage         6       0.0°C1       0.0°C1       0.0°C       -1.4°C       Storage       © User         7       8       10 Feb 118:16       Pass       +0.0°C       -1.4°C       Storage         6       0.0°C1       0.0°C1       0.0°C1       -1.4°C       -1.4°C       -1.4°C       -1.4°C         7       8       10 Feb 118:16       Pass       +0.0°C       -1.4°C       <	Upper	r Modules						© Recall
1       2       3       80:C08       Q010111       10 Feb 11 18:16       Pass       +0.0°C       and Save         1       80:C03       B24       10 Zeb 17 Time       Status       ATEMP       Ch1         1       80:C03       B24       10 Zeb 17 18:16       Pass       -1.4*C       Ch1         2       80:E03       B24       10 Feb 11 18:16       Pass       -1.4*C       Ch1         3       Overridden by upper module       5       storage       ® User       Factory         6			Serial #	Date / Time	Status	ΔΤΕΜΡ		© Compensa
3       80C08       Q010111       10 Feb 11 18:16       Pass       +0,0°C       and Save         4								
4 Lover Modules TH 00Cels Serial # Date / Time Pass ATRMP 1 00C63 B24 02 0ct 10176 Pass -1.4*C 2 08E03 B24 10 Feb 118.16 Pass +0.0°C 3 Overridden by upper module 4 Overridden by upper module 5 Factory 8 Compensation Indicator Button € 1 0 Display 12 Animate Factory 5 Conceptual Pass Pass Pass Pass Pass Pass Pass Pa		80C08	Q010111	10 Feb 11 18:16	Pass	+0.0°C		
CH         Node         Serial #         Date / Time         Status         ΔTEMP           1         80E03         B24         02 Oct 1017.04         Pass         -1.4°C           2         80E03         B24         10 Feb 1118.16         Pass         -1.4°C           3         Overridden by upper module         4.0°C         Storage         ® User           6         6         -         -         -         Factory           8         Compensation Indicator Button         -         Execute         Execute           €         @ Display         @ Animate         Help         Close								
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4 Overridden by upper module 6 7 8 Compensation Indicator Button 8 Ø Display Ø Animate 50,00µs								
6 6 7 8 Compensation Indicator Button € I Display I Animate Execute 50.00µS								Storage
6 7 8 Compensation Indicator Button B ⊠ Display ⊠ Animate Help Close 50,00µs		Overridden b	y upper modu	e				@ Licor
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B Compensation Indicator Button B ⊠ Display ≅ Animate S 0.00µs								Factory
Execute Compensation Indicator Button R I Display I Animate 50.00µs								
Compensation Indicator Button B	°							
e i ⊠Display ⊠Animate Help Close 50.00µs								Execute
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## Dark-level and user wavelength gain compensations

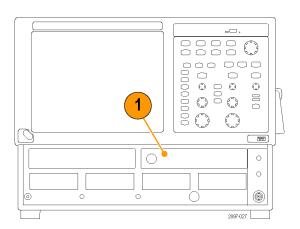
**NOTE.** You should run the Signal Path Compensation procedure before running dark-level or user wavelength gain compensation. (See page 23, Signal path compensation.)

These procedures apply only to optical modules.

Dark-level compensation maximizes the accuracy of the extinction ratio and other optical automatic measurements. Dark-level compensation performs a subset of the module compensation process. It is designed to be fast so it can be performed frequently, just before measurements are taken. Dark-level compensation is not saved and is only valid for the selected bandwidth or filter path and the internal optical power meter.

User Wavelength Gain compensation optimizes an optical channel for your custom input signal.

 Install one or two optical sampling modules in the instrument. Set the acquisition system to run continuously.



2. Select the channel to compensate.



Vertical Horizontal Acquire

3

VERTICAL



2897-028

#### To run the Dark-Level compensation:

 In Vert Setup dialog box, click the Dark Level button under Compensation. Follow the instructions on screen.

**NOTE.** You need to switch from the Basic dialog to the Optical dialog to access the Dark Level Calibration button.

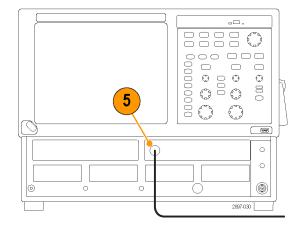
Repeat steps 2 and 4 for any additional optical channels you want to compensate.

#### **To run the User Wavelength Gain compensation** (for signals at wavelengths other than the factory calibrated values; typically 850, 1310 and/or 1550 nm):

5. Use an independently-calibrated average optical power meter to measure the power of an optical signal source.

Then connect the signal to the optical module using the same fiber cable.





6. Click the User Wavelength Gain button in the Vert Setup dialog box.



- 7. Enter the wavelength and measured power of the signal applied to the channel In the User Wavelength Gain Compensation dialog box.
- 8. Click OK to execute the compensation.



## Align acquisition (and TDR steps) for two-channel modules

Small signal misalignments on dual-channel electrical sampling modules can significantly impact differential and common-mode signal measurements. The Differential Channel Alignment application provides a guided procedure to align both the acquisition and (where applicable) the TDR steps of supported electrical sampling modules. This application is available on DSA8300 instruments with TekScope firmware version 6.2.x and later.

You should run the Differential Channel Alignment application whenever you change the instrument module configuration, such as when installing a new supported module, installing or moving supported modules from one slot to another, or installing a module on an extender cable.

Click **Applications > DiffChAlign** to open the application. Open the Online help in the Differential Channel Alignment application for more information.

# **Acquisition**

This section contains concepts of and procedures for using the acquisition system. Detailed information is available in the online help.

# Setting up signal input

Use front-panel buttons to set up your instrument to acquire the signal.

 $\triangle$ 

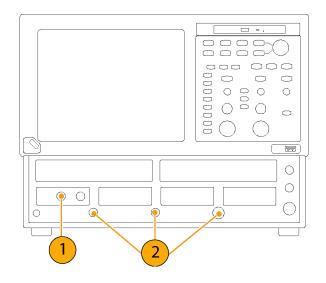
**CAUTION.** Sampling modules are inherently vulnerable to static damage. Always observe static-safe procedures and cautions as outlined in your sampling-module user manual.

 Connect the instrument to the device or signal under test using proper probing or connecting techniques. See the user manual for the installed sampling module for connection requirements.



**CAUTION.** Discharge electrical cables to ground before connecting them to a module.

2. Connect an appropriate trigger signal to the instrument. (See page 38, *Triggers*.)



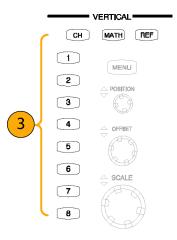
 Push the CH button (turns amber) to assign the waveform buttons (1 – 8) to operate on channel waveforms. Then select the proper waveform button.

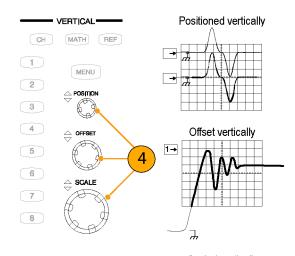
A waveform button lights when its channel is on; when on but not selected, the button is green; when on *and* selected, the button is amber.

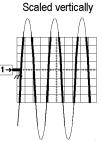
Push the **MATH** button to assign the waveform buttons to math waveforms. If the selected math waveform is not defined, the instrument opens the Define Math dialog box.

Push the **REF** button to assign the waveform buttons to reference waveforms. If no reference waveforms are loaded into the channels, the Recall Waveform dialog box appears.

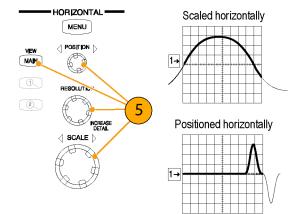
 Use the Vertical Position, Offset, and Scale knobs to adjust the vertical parameters of the selected waveform.







 Push the View Main button to make sure that the main time base view is selected. Use the horizontal Position, Resolution, and Scale knobs to scale and position the waveform on the screen and to set the sample resolution.



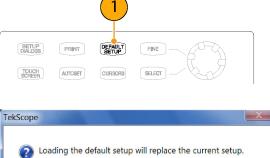
### **Quick tips**

- Vou can click a waveform trace or its reference indicator with the mouse pointer (or touch screen) to select it.
- Push AUTOSET to quickly set up instrument parameters and display a waveform based on the input signal.
- Push Set to 50% in the Trigger controls, if required, to stabilize the display when using the Trigger Direct Input connector.

Continue?

### Using factory default setup

- 1. To quickly return to the factory default settings, push **DEFAULT SETUP**.
- 2. Click Yes to restore the settings.



2

Yes

No

## **Using Autoset**

Use Autoset to automatically set the instrument vertical, horizontal, and trigger parameters and display a waveform based on the characteristics of the input signal.

NOTE. Make sure that the input channel(s) for the signal are on and selected before doing an autoset.

1. Push the AUTOSET button to execute an Autoset.

If you use Autoset when one or more channels are displayed, the instrument uses the selected channel for horizontal scaling. Vertically, all channels in use are individually scaled.

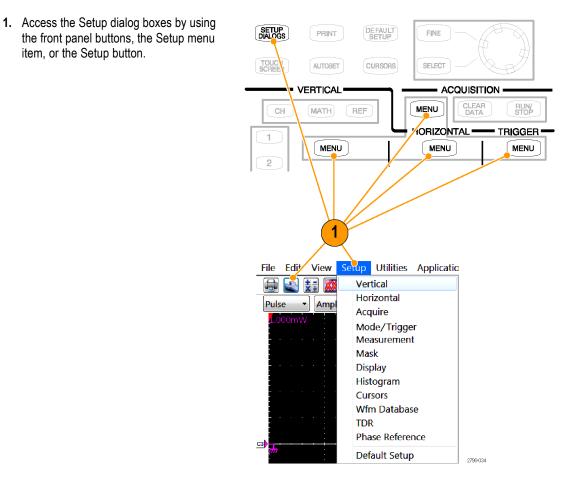


### **Quick tips**

- If the instrument does not autoset to your signal, select Setup > Horizontal, click the Comm Standard button, and select the signal type. Then push the Autoset button again.
- Select Utilities > Define Autoset to change the Autoset properties.

## Accessing the Setup dialog boxes

The Setup dialog boxes are the key controls for setting instrument parameters such as Mode/Trigger, horizontal, vertical, acquisition, cursors, histogram, display, and mask.



2. Click on the tabs to select among the setup dialog boxes.

	Setups					X
	Wfm Datab	ase	Hist		Cursor	Meas
2 -	Phase Ref	1	Mask		TDR	Disp
	Vert Horz		rz	Acq		Mode/Trig
Ľ	<u> </u>					

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34

### Changing the acquisition mode

Use the procedure that follows to set the data-acquisition mode and specify acquisition start and stop methods.

MENU

ACQUISITION

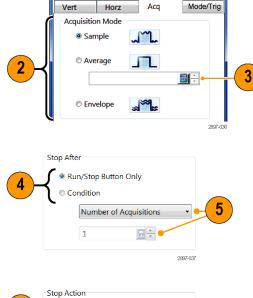
DATA

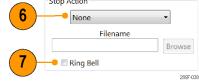
RUN/

- 1. Push the Acquisition **MENU** button to display the Acq Setup dialog box.
- **2.** Select the acquisition mode.
- 3. For Average mode, enter the number of samples to average.
- Set the Stop After mode and action by selecting Run/Stop Button Only or Condition.
- 5. If you selected Condition, choose a condition on which to stop from the drop-down list. If the condition requires a count, enter a count.
- 6. Enter a filename if you selected Print to File or Save all Waveforms.
- Select Ring Bell if you want the instrument to produce an audio tone when the acquisition stops.

**NOTE.** You must connect an external speaker to the instrument to hear a tone on a stop condition.

- 8. Push RUN/STOP to start the acquisition.
- 9. Push **RUN/STOP** again to stop the acquisition.







#### **Quick tips**

- Run/Stop is available on both the front panel and the touch screen.
- If Stop After is set to Condition, pressing RUN/STOP causes only one acquisition to run if the original condition has been met. You need to push CLEAR DATA so that the condition must be met again.

### Waveform databases

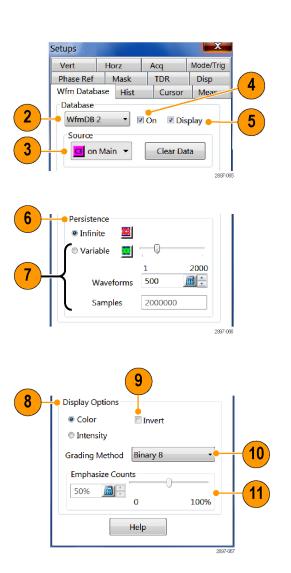
**NOTE.** Certain measurements require the use of a waveform database. The instrument automatically sets the measurement system to use a waveform database if one is available.

The four available waveform databases can be used for measurements, histogram calculations, mask testing, and generating a density-style, graded display. Waveform databases may be automatically allocated for measurements, histograms, and mask testing.

- 1. Select Setup > Wfm Database from the main menu.
- 2. From the pulldown menu under Database, select one of the four available databases.
- 3. Click the **Source** button to select the waveform source.
- 4. Click **On** to start accumulating data from the selected source.
- 5. Click **Display** to turn on the display of the waveform database.
- **6.** Select the Persistence mode for the selected waveform.
- If you selected Variable persistence, you can specify the number of waveforms that are included in the waveform database.

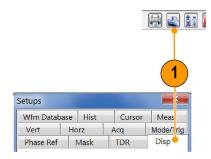
**NOTE.** The following Display Options affect all waveform databases that you display.

- 8. Click a grading display option.
- **9.** Click **Invert** to emphasize the least occurring pixels by reversing the intensity/color assignments to each grading partition.
- 10. Select one of the four grading methods.
- **11.** If you selected one of the two Emphasized grading methods, slide the Emphasize Counts percentage control to specify the range of counts you want emphasized.



# Setting the display style

1. Click the Setup button and click the **Disp** tab.

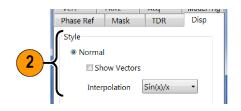


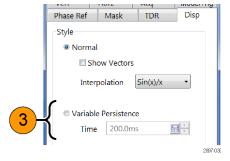
 Select a waveform display style.
 Normal selects a display with no acquisition data persistence. Waveforms are displayed with the new data from ongoing acquisitions replacing data acquired from previous acquisitions.

**Show Vectors** turns on display lines between waveform dots; deselect to display only dots.

- Sin(x)/x interpolation computes record points using a curve fit between the acquired samples.
- Linear interpolation computes record points between actual acquired samples by using a straight line fit.
- 3. Variable Persistence makes data persist for a specified time. New waveform displays accumulate data as new waveform records acquire, but with continuous replacement of the oldest data.

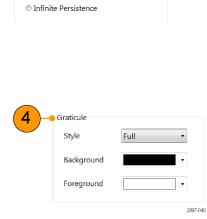
Set a time at which the oldest data is removed.





Infinite Persistence makes data persist until you change some control or explicitly clear the data. Waveform displays accumulate data as the instrument acquires new data, resulting in a buildup of data in all time slots.

**4.** Use the Graticule settings to select the graticule style and the graticule color and screen background.



# Triggers

This section contains concepts and procedures for using the trigger system. Detailed information is available in the online help.

## **Triggering concepts**

### **Trigger event**

A trigger event occurs when the trigger source (the signal that the trigger circuit monitors) passes through a specified voltage level in a specified direction (the trigger slope). The trigger event sets the time-zero point in the waveform record and all sampled waveforms on all inputs are measured with respect to that event.

When a trigger event occurs, the instrument acquires one sample of all active (selected) signals. When the next trigger event occurs, the instrument acquires the next sample. This process continues until the entire record is filled with acquired samples. Without a trigger, the instrument does not acquire any samples. Sampling oscilloscope behavior differs from that of real-time acquisition systems, which can acquire a complete waveform record from a single trigger event.

#### **Trigger sources**

The trigger source sets the source that the trigger system monitors for a trigger event. The source can be:

- A clock signal used for acquiring optical or electrical serial data streams. The source of the clock can be internal or external to the instrument:
  - External Clock Input/Prescale Trigger. Connect the trigger signal to the front panel connector. Triggering is guaranteed for clocks from 150 Mb/s up to 15 Gb/s (and will typically work up to 20 Gb/s).
  - Internal Clock-recovery trigger. This trigger source can be an optical sampling module that is equipped with a clock-recovery option, or a dedicated electrical clock recovery module. Available clock recovery triggering rates depend on the sampling module. For example, the 80C08C Optical Sampling Module with option CR4 provides internal clock-recovered triggers for any data rate (standard or custom) from 8.5 Gb/s to 12.5 Gb/s.
- The instrument TDR clock, with selectable TDR Step repetition rates. The TDR CLOCK OUT connector on the instrument front panel supplies a replica of the TDR clock,
- A low-repetition rate signal (DC to 3 GHz) connected to the External Trigger Direct input. While this trigger source can be used to acquire serial data signals at rates up to 3 Gb/s, its primary use is for low repetition rate (<150 MHz) signals or for signals where you need additional conditioning of the input trigger signal (such as trigger level, slope, and so on). This flexibility comes at the cost of increased instrumentation jitter.</p>
- An internal clock for Free Run acquisition of signals. (Since the acquired signals are not synchronous with the trigger, this trigger source is useful primarily for locating a signal or clock and applying the appropriate offset to the data or trigger for proper synchronous waveform acquisition.)

#### **Trigger modes**

When a Clock source is selected (whether Internal Clock recovery or external Clock Input/Prescale Trigger input) as the trigger source, you must select the Trigger Mode. Available trigger modes are Eye, Pattern, and Other:

- Select Eye mode if the signal you are acquiring is synchronous with the selected clock source and you want to display the acquired data as an "eye diagram" overlaying all of the acquired data bits with minimal clock to data jitter.
- Select Pattern mode if the signal you are acquiring is synchronous with the selected clock source and you want to display the individual bits as a "bit stream", with minimal clock to data jitter.

NOTE. Pattern mode is only available if Option ADVTRIG is installed on the instrument.

Select Other mode if the signal you are acquiring is synchronous with the selected clock source and you want to display the acquired data showing the effects of any clock modulation (such as Spread Spectrum Clocking).

Application	Waveform display	Trigger Source/Mode
Optical or Electrical Serial Data (NRZ) Mask		<ul> <li>Trigger Source: Clock Input/Prescale Trigger input or Internal Clock Recovery</li> </ul>
and Parametric Testing (minimum jitter)		<ul> <li>Clock Trigger Mode: Eye</li> </ul>
Optical or Electrical Serial Data Pattern		<ul> <li>Trigger Source: Clock Input/Prescale Trigger input or Internal Clock Recovery</li> </ul>
Analysis (including JNB analysis)		<ul> <li>Clock Trigger Mode: Pattern (this mode of operation requires the Advanced Trigger Option ADVTRIG).</li> <li>Maximum supported pattern length= 2<sup>23</sup>.</li> </ul>
Optical or Electrical Serial Data (NRZ) Mask		<ul> <li>Trigger Source: Clock Input/Prescale Trigger input or Internal Clock Recovery</li> </ul>
and Parametric Testing (w/ clock modulation effects – SSC)		Clock Trigger Mode: Other
Clock Signal Analysis		<ul> <li>Trigger Source: Clock Input/Prescale Trigger input or Internal Clock Recovery</li> </ul>
		Clock Trigger Mode: Eye

#### Table 1: Application-based trigger modes

Application	Waveform display	Trigger Source/Mode
TDR/TDT and S-Parameter Analysis		Trigger Source: TDR
Low Repetition Rate Signals		Trigger Source: External Direct Trigger input

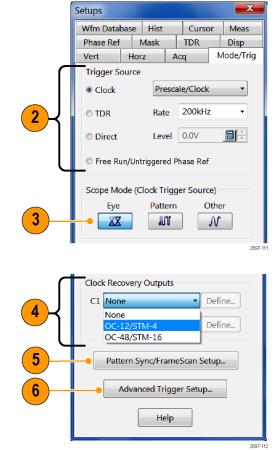
### Table 1: Application-based trigger modes (cont.)

### Setting trigger controls

Nearly all trigger parameters are set in the Mode/Trig Setup dialog box.

- Push the Trigger MENU button to display the Mode/Trig Setup dialog box.
- 2. Select a trigger source.
- 3. If the trigger source is Clock, select the **Scope Mode**.

- 4. Use the Clock Recovery Outputs fields to select a measurement standard and define clock recovery parameters on applicable modules.
- 5. Click Pattern Sync/FrameScan Setup to set pattern sync, autosync and FrameScan parameters. (See page 42, Setting Pattern Sync and FrameScan controls.)
- 6. Click Advanced Trigger Setup to set trigger level, slope, holdoff, and other trigger parameters.



#### **Quick tips**

- Selecting Clock > Prescale/Clock as the trigger source requires that an appropriate trigger signal be connected to the CLOCK INPUT/PRESCALE TRIGGER input connector.
- If you select the Clock trigger source, you also need to select the Scope Mode (Eye, Pattern, or Other).
- Pattern (Scope Mode) triggering is only available if the Advanced Trigger option ADVTRIG is installed on the instrument.
- If you select Pattern (Scope Mode), use the Pattern/Sync/FrameScan Setup dialog to specify the pattern characteristics.
- Selecting a Clock Recovery trigger source requires that a module with clock recovery is available. Select the clock recovery standard from the pulldown lists or user-specified range controls.
- Selecting TDR as the trigger source uses the clock frequency setting in the Rate control.

- Selecting Direct as the trigger source requires an appropriate trigger signal be connected to the DIRECT INPUT connector.
- The Level control applies only when the trigger source is set to Direct.

### Setting Pattern Sync and FrameScan controls

**NOTE.** The pattern sync controls are only available if the instrument has the ADVTRIG option installed and the instrument is set up for Pattern Trigger mode.

1. Select Setup > Mode/Trigger. 2 Pattern Sync/FrameScan Setup. 2. Click Pattern Sync/FrameScan Setup. Advanced Trigger Setup.. Help 3. Select the parameters for pattern Pattern Sync/FrameScan Setup synchronization: Pattern Sync Control AutoSync Options Select the Data Rate (bit rate) (default Data Rate E 🗧 List... 🗹 Data Rate Pattern is 2.48832 Gb/s). List... Pattern Length Length 3 Data:Clock ÷ Edit... ☑ Data:Clock Ratio Select the Pattern Length (default is Ratio 127). AutoSync to Selected Waveform Main Position BTZ Select a Data:Clock Ratio FrameScan Scan Bits (data-to-clock ratio) (default is Enabled 64 Clock: Source 1:1). Clock/Prescale Reset Set the Main timebase delay position. Close Help This is the same control as found in the Setup > Horizontal tab. 4. Use the AutoSync feature to Pattern Sync/FrameScan Setup automatically detect the data rate, Pattern Sync Control AutoSync Options pattern length and/or data-to-clock ratio Data Rate 🖃 🗧 List... 🗹 Data Rate of the applied data and clock signals Pattern (data to a sampling module channel and 📑 🗧 List... Pattern Length Length the clock to the Clock/Prescale Trigger Data:Clock ÷ Edit... Data:Clock Ratio Ratio input, or from an internal clock recovery AutoSync to Selected Waveform source). Position 🔜 🗧 🖪 BTZ FrameScan Set as New Reference Scan Bits

Clock Source

 Enable FrameScan to automatically scan through a pattern (or part of a pattern).
 This FrameScan control is the same as the FrameScan control in the Horizontal Setup dialog box (changing either one affects the other).

5

Enabled

Help

Close

64

Reset

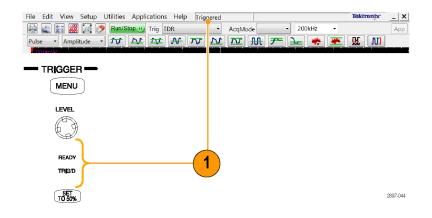
#### **Quick tips**

- All pattern sync controls are disabled (grayed out) if the Advanced Trigger option (ADVTRIG) is not enabled in the instrument, or the Trigger Source is not set to Clock, or the Scope Mode is not set to Pattern.
- The Data Rate in the Pattern Sync dialog box is tied to the Bit Rate control in the Horizontal setup dialog box. Changing either one affects the other.
- If the entered Data Rate does not match the rate of the selected communication standard in the Horizontal Setup, then the communication standard is changed to User.
- For highest reliability and speed, manually enter as many control values as possible. Uncheck the control value in the AutoSync Options area to enable manual entry.

### **Checking trigger status**

You can check the status of the trigger from the front panel and in the application status bar. The status bar also displays the waveform count.

 Check the READY and TRIG'D front-panel controls to determine the trigger status, or look at the trigger status in the application.



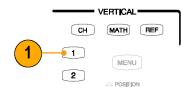
# Waveform measurements

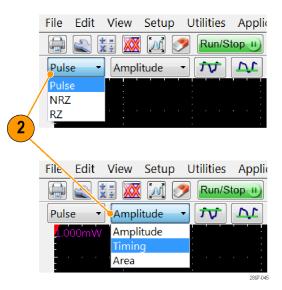
Your instrument features automatic measurements (with statistics), cursors, histograms, and waveform math processing to assist you in analyzing waveforms. This section contains concepts and procedures for analyzing waveforms. See the online help for more information.

## Taking automatic measurements

Automated measurements are divided into waveform types (Pulse, NRZ (Non-Return-to-Zero), and RZ (Return-to-Zero)) and measurement categories (amplitude, time, and area).

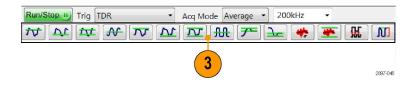
- Select the waveform to measure. You can measure a channel, reference, or math waveform.
- Select the waveform type and category from the buttons on the Measurement bar.

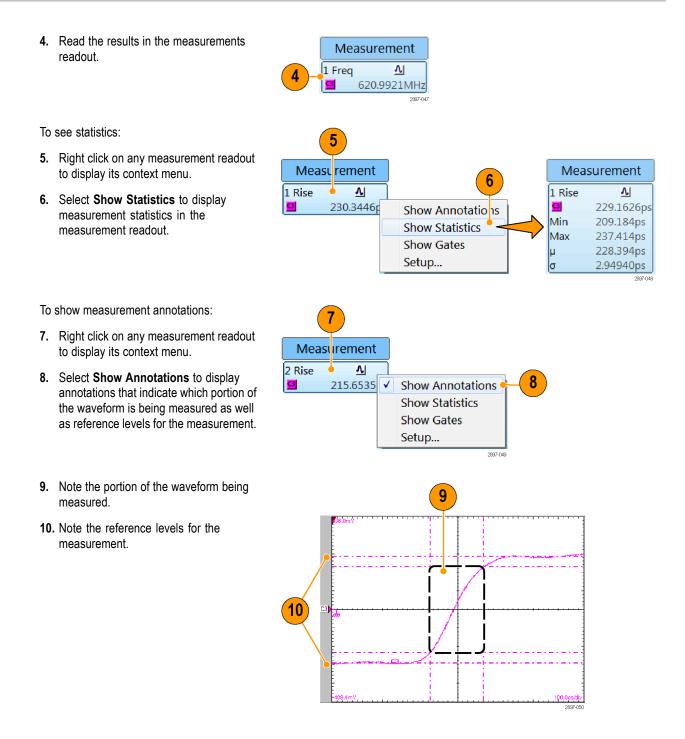




 Click on a measurement button in the Measurement tool bar. The instrument displays the most frequently used measurements for the selected waveform type and category.

You can also access all of the measurement types from the MEAS setup dialog box.





To measure a waveform database:

11. Select Setup > Meas from the application menu bar.

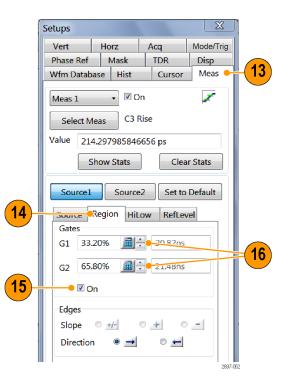
In the Meas Setup dialog box, make sure to select a measurement slot (one of **Meas 1** through **Meas 8**).

12. In the Source tab, check the Use Wfm Database option.

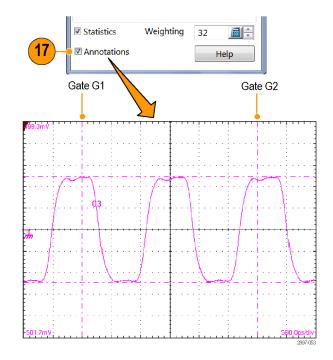
	setups						
	Phase R	ef I	Mask	Т	DR	Disp	
	Vert	Ho	rz	Ao	q	Mode/Trig	
	Wfm Dat	abase	Hist		Cursor	Meas 👝	(11
	Meas 1		• <b>0</b>	n		*	
	Select	t Meas	C3 P	k-Pk	Noise		
	Value	5.00000	 )000 μW	1			
		Show	Stats		Clea	r Stats	
	Sourc	e1	Source	2	Set to	Default	
	Source	Regi	on HiL	ow	RefLev	el	
	C3 on	Main	•				
12			atabase		Clea	ır	
		al Type- ulse	NRZ	,	RZ		
		λ		_	Δ		
	🗖 Statisti	CS	Weigh	ting	32	× •	
	🗷 Annota	itions				Help	
	0					2897-06	51

.

- To localize a measurement:
- 13. Select Meas.
- 14. Select the Region tab.
- **15.** Click the **On** box to turn gating on and to display the gates on screen.
- 16. Use the G1 (Gate1) and G2 spin controls to adjust the gates on screen such that the area to measure is between the gates.



**17.** Click the **Annotations** box to display which portion of the waveform is being measured and the reference levels for that measurement.



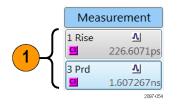
### **Quick tips**

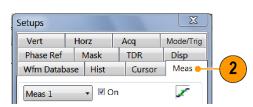
- If, at the time you first create a measurement, the measurement source you select is displayed as a waveform database, the database will automatically be measured. Deselect the User Wfm Database option if you want to measure the vector waveform instead of the database.
- Gate values are entered as a percentage of the waveform, displayed from left to right. If no keyboard is installed, access the virtual keyboard and use the touch screen to enter values.
- You can select and drag the gates to new locations by using a mouse or the touch screen.

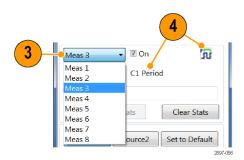
### Turning off automatic measurements

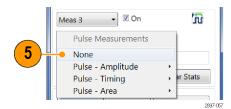
You can assign and display up to eight automatic measurements. If you need an additional automatic measurement, and all measurement slots are used, reassign a current measurement slot to the new measurement.

- Note the current measurement assignments. In this example, measurement slots 1 and 3 have measurements assigned and displayed.
- 2. Select Meas (measurement) from the Setup dialog box.
- **3.** Use the pulldown list to select **Meas 3** (measurement slot 3).
- Note that measurement slot 3 has a measurement assigned and is displayed (On).
- 5. Click Select Meas > None to disable measurements on slot 3.
- 6. Note that measurement slot 3 is now labeled Not Defined and no measurement icon is displayed.
- Note that measurement slot 1 has a measurement assigned. It is set to not display, but the measurement slot is still used.













### Quick tip

To easily redefine a measurement slot, select Select Meas and choose a new measurement.

### **Cursor measurements**

Use cursors to measure amplitude and time quickly and with more accuracy than when visually using the graticule to take measurements. Because you position cursors wherever you want on the waveform, they are easier to localize to a waveform segment or feature than automatic measurements.

AUTOSET

Horz Acq

Phase Ref Mask TDR

Wfm Database Hist Cursor

CURSORS

Mode/Trig

Disp

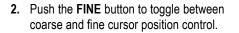
Meas

TOUCH

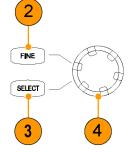
Setups Vert

> Function Off Vertical Bars Horizontal Bars Waveform

- 1. Push the CURSORS button:
  - Once for Vertical Bars
  - Twice for Horizontal Bars
  - Three times for waveform cursors



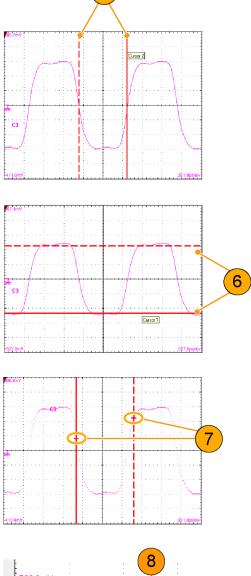
- Push the SELECT button to toggle selection between the two cursors. The active cursor is represented by a solid line.
- Turn the General Purpose knob to position each cursor on the waveform to measure the feature that interests you.



5. Vertical bars (V Bars) measure horizontal parameters (time, bits or distance).

6. Horizontal bars (H Bars) measure amplitude parameters (volts, watts, ohms, rho).

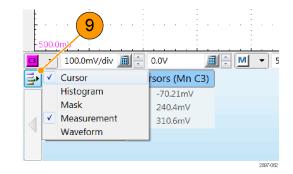
- 7. Waveform cursors measure vertical and horizontal parameters simultaneously. Waveform cursors are attached to the waveform and track with the waveform points.
- 8. Read cursor measurement results in the readouts area of the display.



5

	500.0m\			<b>)</b>	<u> </u>		
C3	• 1	00.0mV/div 🧾	1	0.0V		<u> </u>	
<b>-</b>	Me	asurement	Cι	irsors	(Mn	C3)	
	1 Freq	۸I	v1	-70.	21mV		
	<b>3</b>	623.3226MHz	v2	240	.4mV		
	3 Prd	۸	Δv	310	.6mV		
	<u>3</u>	1.604306ns					
							2897-061

**9.** Click this button to show or hide the cursor readouts.



#### **Quick tips**

- Cursors require that at least one waveform is selected on the screen.
- Waveform cursors are not available if a waveform database is selected.
- You can drag a cursor to place it relative to the waveform.
- You can assign each cursor to a different waveform to measure differences between waveforms. Make these selections in the Cursor setup dialog box.
- If you use two magnified time base views, you can take precision timing measurements between two distant points on a waveform. Magnify each point of interest in a separate time base, and then place one cursor on each point. The Δ-time cursor readout will then reflect the position and resolution of the magnified time bases.

### Math waveforms

You create math waveforms by creating a math expression using the Define Math dialog box. In that dialog box, you apply numerical constants, math operators, and functions to sources (live or reference waveforms), measurement scalars (measurement readouts), or fixed scalars. You can display and manipulate these derived math waveforms much like you can the channel and reference waveforms.

VERTICAL

MATH

1

2

Math Waveform

M1 Fun M2 M3 M4

> M5 M6

\_M7 \M8 REF

On

Diff(

Log(

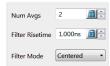
Avg( 2897-063

CH

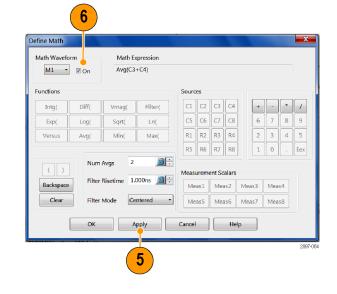
- Push the Vertical MATH button (once or twice if needed) to display the Define Math dialog box.
- Click the Math Waveform drop-down list in the dialog box and select one of the eight available math waveforms.

- Use the dialog box to define a math expression. Some guidelines for creating your expression follow:
  - Sources (C1 C8, R1 R8, and Meas 1 - Meas 8) should be set up before you use them (references and automated measurement scalars should be defined).
  - Elements that appear grayed out cannot be selected because they would result in an illegal entry.
- 4. Use the filter control in the dialog box to specify the rise time of any filters in the math waveform definition.

Define Math												×
Math Waveform Math Expression												
Functions				Sourc	es							
Intg(	Diff(	Vmag(	Filter(	C1	C2	<b>C</b> 3	C4		+	- (	*	/
Exp(	Log(	Sqrt(	Ln(	C5	C6	C7	C8		6	7	8	9
Versus	Avg(	Min(	Max(	R1	R2	R3	R4		2	3	4	5
				R5	R6	R7	R8		1	0		Eex
() Backspace	Num Filter	-	 000ns	Meas	ureme as1	ent Sc Mea		Mea	~2	Mea	c.4	
Clear	Filter	Mode	ntered 🔹		as5	Mea		Mea	_	Mea		
	ОК	A	pply	Cancel			He	р				



- 5. When you have defined the expression, click **Apply**.
- 6. Select the Math Waveform On box to display the waveform.



### **Quick tip**

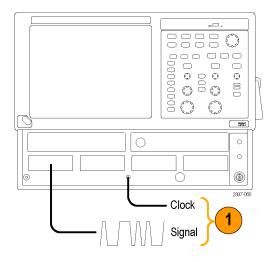
If you select a waveform that is already defined, its math expression appears in the dialog box. To use the waveform, click the Clear button, which discards its previous math expression.

### Display a communication signal

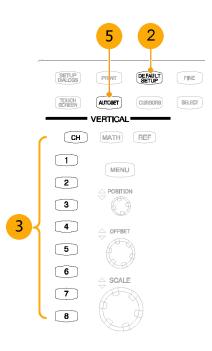
 Connect signals to the sampling module (Data signal to the module input, clock signal to the CLOCK INPUT/PRESCALER TRIGGER connector).



**CAUTION.** Always observe optical cable and static-safe procedures and cautions as outlined in your sampling-module user manual when connecting cables to modules.



- 2. Push the **DEFAULT SETUP** front panel button and click YES to load the default instrument setup.
- **3.** Select the input signal source (1–8).
- 4. Select Setup > Horizontal and enter the communications standard or set the bit rate of the signal.
- 5. Push the AUTOSET front panel button. The instrument analyses and displays the signal.



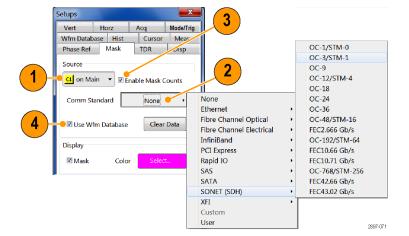
### Mask testing

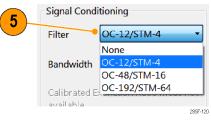
Use mask testing to test your waveforms for time or amplitude violations against a predefined industry standard or a user-defined mask. Mask testing counts waveform samples (called hits or violations) that occur inside of a specific area (the mask). This instrument provides many predefined standard masks (including Ethernet, SONET/SDH, and Fiber Channel (Optical and Electrical)). You can also use the mask edit tools to create a custom mask.

- 1. Select the waveform to be mask tested from the drop-down list under Source.
- Select a standard mask in the Mask setup dialog box. Selecting a communication standard or user-defined mask automatically:
  - Displays the mask on screen and autosets for the mask if Automatic is checked in the dialog box.
  - Enables mask testing.
  - Displays mask count statistics in the mask readout. You do not have to display a mask to enable mask counting.
- If you want, disable mask counts. (Selecting a mask in step 2 automatically enabled them.)
- 4. Check Use Wfm Database to use a waveform database as the waveform source.
- If applicable to your selected Comm Standard, click the Vert tab and select a signal conditioning filter. Then click the Mask tab to return to the mask settings.

#### To autoset the waveform to the mask:

6. Click the Autoset Data button to perform a manual autoset on the mask-source waveform.





	Autoset Data to Mas	k	
6	© Automatic • I Manual • Autoset Data	−HiLow Method –	
			2897-

 Select the HiLow Method to determine the signal High and Low values, used to align the input signal to the mask:

**NOTE.** When using a standard mask, the instrument automatically selects the appropriate HiLow Method:

**Mean** sets the Mask Autoset to use the mean value of the High level (topline) and Low level (baseline), taken within the fixed eye aperture (center 20% of the eye), to align the input signal to the NRZ mask.

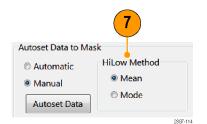
**Mode** sets the Mask Autoset to use the High level (topline) and Low level (baseline), taken across one unit interval of the eye diagram, to align the input signal to the NRZ mask.

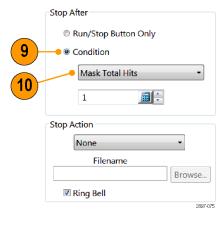
#### To set a Stop Action:

- Select Setup > Acquire in the main menu to open the Acq setup dialog box.
- 9. In the Acq Setup dialog box, check the Condition option under Stop After.
- In the Condition pulldown list, select a mask-related criteria, such as Mask Total Hits and set a count, such as 1, in the count box.

These settings stop acquisition when mask violations satisfy the criteria you set.

**11.** Push the **RUN/STOP** button to restart acquisition, if stopped.







#### To autofit the mask to acquired data:

For best mask testing results (such as best mask test margin), auto-fit the mask to a waveform data set after acquiring an adequate number of waveforms.

**NOTE.** Mask auto-fitting only works when mask testing on data in a waveform database.

- Push RUN/STOP to stop data acquisition (or use the automatic Stop After Condition; see steps 8 - 10).
- Click the Autofit Mask button in the Mask setup tab. If the Autofit Mask button is grayed out, select Enable Mask Counts at the top of the Mask tab.

#### To restart testing:

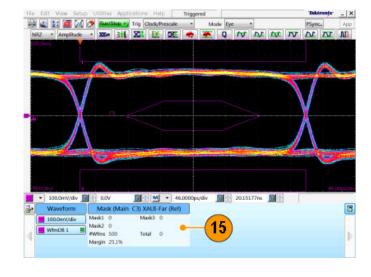
- To restart after a Stop After condition occurs, push the front-panel CLEAR DATA button, followed by the RUN/STOP front-panel button.
- **15.** Read the mask-hits count and margin percent (if enabled) in the readout.



Autofit Mask

Autofit Mask to Data

13



 You can use Mask Margins to explore design margins of your communications signal.

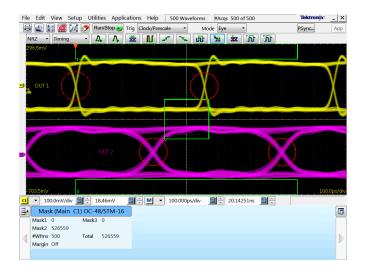


# To do mask testing on multiple simultaneously acquired channels:

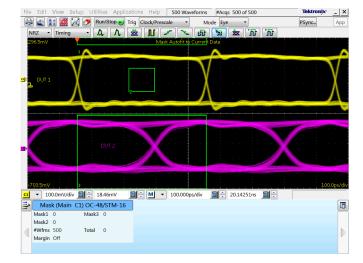
Prerequisites:

- Mask testing must use the same mask for all acquired signals
- All signals must be acquired into waveform databases
- At least one complete "eye" (two clear crossings) must be visible for all signals being tested.
- **17.** Set up the first channel on which to perform a mask test (steps 1 4).
- **18.** Select the **Use Wfm Database** box in the Mask Setup tab.
- 19. Select additional signals to test. Scale and position the waveforms such that at least one clear eye pattern is visible for each waveform at the same time. The image shows two waveforms with clear eyes (two clear crossings per eye, as indicated by circles on the image).
- **20.** Assign each waveform to a waveform database, and acquire an adequate number of waveforms.

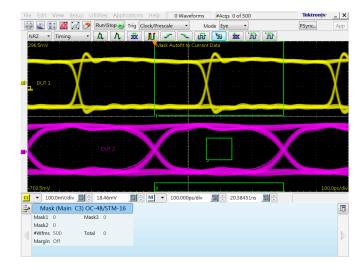
 Stop signal acquisition (press the RUN/STOP button or use the Automatic Stop After condition).



- **22.** Select the signal on which to run a mask test (Channel 1 in the example image).
- 23. Select Setup > Mask and click the Autofit Mask button to fit the mask to the first signal to be tested against the mask. View the results in the Mask readout.



24. Repeat steps 22 and 23 to test each acquired channel against this mask. The example shows the mask autofitted first to the channel 1 waveform and then to the channel 3 waveform.



#### **Quick tips**

- Selecting a source that is currently displayed as a waveform database automatically enables mask testing on the database. To mask test the waveform instead of its database, deselect the Use Wfm Database box.
- You can choose to autoset the mask-source waveform to the mask each time you select a new mask standard by checking Automatic under Autoset.
- Pushing the RUN/STOP button after acquisition has stopped due to a Stop After condition being met causes the instrument to acquire one (and only one) additional waveform.
- The Clear Data button resets all mask counts. In addition, if the source for mask testing is a waveform database, clicking this button clears the waveform database.

# FrameScan

Use FrameScan to test a specific bit (or range of bits) in a repeating frame of data. FrameScan acquisitions allow detailed display and analysis of individual, complete waveforms or of the bit sequences leading up to a failure. This ability to identify the specific patterns that caused the failure makes the FrameScan mode superior to traditional methods.

- 1. Select the Horizontal Setup tab.
- 2. Click Pattern Sync/FrameScan Setup.

Setups				<b>—</b> ×			
Wfm Data		list	Cursor	Meas			
Phase Ref		sk	TDR	Disp			
Vert	Horz	•	Acq	Mode/Tr			
Timebase			_				
MainT	В		•				
Scale		1.429	9bits	i t			
Position		4.644	<u></u>				
Resolutio	Resolution		4.595ps				
Record L	ength	2000	<b>a</b> ÷				
Horizont Referenc			100.0%				
All Timeb	ases						
Comm S	tandard		None	•			
Bit Rate	155	.52000	Mbps	<u>.</u>			
Units							
© Seco	nds	Bits	© Dista	ance			
	Un	its Setu	q.				
Display S	scale						
© Per E	vision	Per Screen					
e Pat	tern Syn	c/Fram	neScan Setu	ıp			
		Help					

- 3. Click Enabled in FrameScan.
- 4. Set the Scan Bits to the number of bits or subframes to acquire.

Pattern Sync/FrameScan Setup	
Pattern Sync Control	AutoSync Options
Data Rate	. 🗹 Data Rate
Pattern Length	. 🗹 Pattern Length
Data:Clock 🔁 Edit.	. 🗹 Data:Clock Ratio
Position RTZ	AutoSync to Selected Waveform
Set as New Reference           Clock Source	FrameScan Scan Bits
Close	Нер
	2897-079

## To use TDR

To take TDR measurements, you must have a TDR-capable sampling module installed and your DUT must be attached to the TDR sampling module.

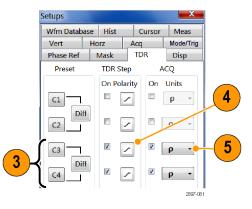
2

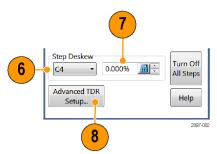
- 1. Select TDR from the Setup menu.
- 2. Click the **channel** button to automatically display the incident and reflected steps of the selected channel by automating the following tasks:
  - Turns on the channel.
  - Turns on a step.
  - Sets trigger source to TDR.
  - Sets acquisition to Averaging.
  - Changes display style to Show Vectors.
- 3. Select a channel pair on which to perform a differential TDR measurement. Click **Diff** to automatically set up the differential measurement for the channel pair.

All the tasks listed in step 2 are performed for both channels and the pulse polarity of the second channel is set to negative.

- 4. Click the polarity button to toggle the step edge.
- 5. Set the vertical scale Units to V (volts),  $\Omega$  (ohms), or  $\rho$  (rho).
- 6. If performing differential TDR, select the channel (TDR module with dual channel adjustment) or the even-numbered channel of the channel pair (TDR module with single channel adjustment) for deskew adjustment.
- 7. Set the Deskew percent value.
- 8. Click Advanced TDR Setup to set the TDR step rate, reference source, and enable or disable incident waveform display.

					(		)		
	Setups	×							
	Wfm Databa	ase	Hist	Curse	r	Meas			
	Vert	Ho	orz Acq				Mode/Trig		
	Phase Ref	1	Mask		TDR 🤇		Disp		
	Preset		TDR Step			ACQ			
			On Po	y Or	On Units				
			• [	~			ρ -		
	C2 Dif	1		~			ρ -		
	• 🖪 🗖		☑ [	~	V		ρ -		
-	C4 Dif	Ţ	♥ (	~	V		ρ •		
	•						2897-060		





### **Quick tips**

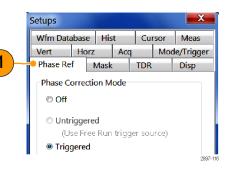
- Use a lower TDR step rate to take measurements on long cables.
- For a TDR module with single channel deskew capability, only the even-numbered channel of the module is selectable for deskew. For a TDR module with dual channel deskew capability, both channels of the module are selectable for deskew. (See page 68, Skew and deskewing.)

## **Phase reference**

Use phase reference correction when you need to acquire signals with ultra low jitter. Using a phase correction reference clock effectively reduces trigger jitter in the instrument, which lets you measure clock and other phase noise (jitter) with more accuracy.

**NOTE.** To use the phase reference function, you must have a phase reference module (such as the Tektronix 82A04B), and a phase reference clock signal that is synchronous to the data to be acquired and connected to the phase reference module. Refer to the online help for more information on using the phase reference function.

 Select Setup > Phase Ref to display the Phase Reference dialog box.

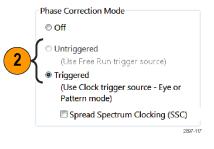


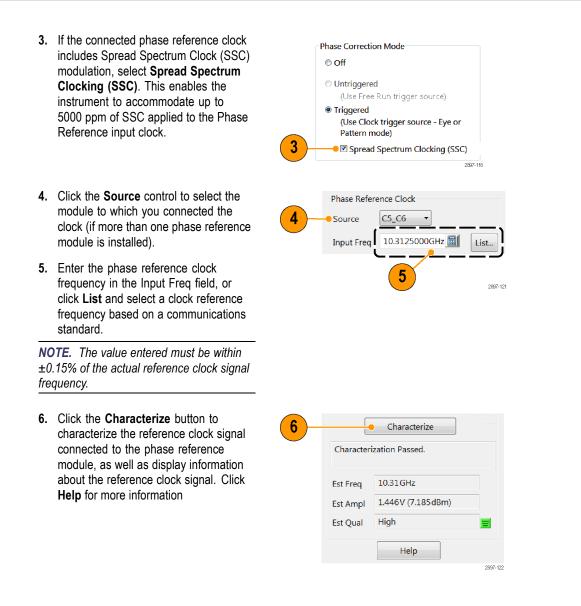
- 2. Turn Phase Correction on by selecting Untriggered or Triggered.
  - Untriggered: Enables the phase correction timebase, but runs it in a Untriggered mode in which the trigger is ignored for purposes of determining the horizontal acquisition window (for example, when displaying a signal as an eye diagram or for signals where the phase reference clock signal is > 15 GHz).

**NOTE.** The trigger source must be Free Run (set in the Setup > Mode/Trigger dialog) to select Untriggered phase correction mode.

 Triggered: Enables phase correction and the clock trigger source is used to determine the horizontal acquisition window.

**NOTE.** The trigger source must be Clock and the scope mode Eye or Pattern (set in the Setup > Mode/Trigger dialog) in order to select Triggered phase correction mode.





### Phase Reference key points

- When to use: Use Phase Correction when you need the highest timing fidelity for measurements on input signals. Phase correction, when on, uses a phase-reference clock you supply to change the timebase (thereby altering the sampling and acquisition process) of the main instrument so that jitter measured using this "phase-corrected" timebase is the jitter between the data and your clock. With little instrument trigger jitter present, the phase-corrected acquisitions increases the timing fidelity of your measurements.
- Untriggered mode: Select the Untriggered Mode when you want acquired waveforms that are phase corrected, but not acquired relative to a trigger, such as when displaying communication signals as eye diagrams, or when the frequency of your phase correction clock signal is higher than the frequency at which the CLOCK INPUT/PRESCALE TRIGGER front panel input can operate.

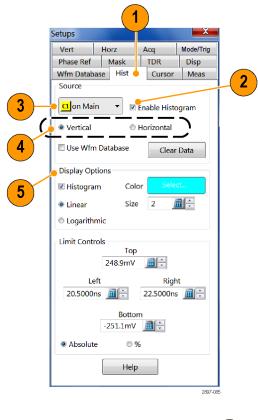
- Triggered mode: Select Triggered mode when you want acquired waveforms that are phase corrected, and acquired relative to a trigger event or reference. Sampling is still random around the trigger event. Use this mode when in Pattern Clock triggered mode to examine serial data patterns with very low jitter or for multi-phase eye diagrams when in Eye Clock triggered mode.
- Spread Spectrum Clocking (SSC): Enable SSC support when you want to acquire waveforms that are phase corrected and acquired relative to a trigger event that is using a Spread Spectrum Clocking signal. Sampling is still random around the trigger event.
- Reference clock signal: You must connect a phase reference clock signal to the selected phase reference clock input source. The instrument then measures the phase reference clock signal to derive the timebase, which is one period of the reference clock. Whenever samples are taken on any (or all) of the acquisition-module channels, the Phase Reference Module simultaneously measures the phase of the supplied reference clock. The instrument uses the phase information to horizontally position the associated data properly in the waveform record. The value you enter in the Input Freq field must be within ±0.15% of the actual reference clock signal frequency.
- Reference clock frequency parameter: Because time is measured as periods of the reference clock, you must enter the frequency of the reference clock so that the instrument can translate period intervals back to time intervals for display and measurement purposes.
- Reference clock characterization: Once you have connected a clock and entered its frequency, click the Characterize button to characterize the clock signal. After running the characterization, you can determine its results by reading the status in the Phase Reference Setup dialog box.
- Reference clock relative signal quality: The relative quality readout (High. Med, or Low) of the characterized phase reference clock is based on the slew rate of the phase reference clock signal, where a higher slew rate corresponds to a higher-quality reference signal. Generally, a higher slew rate results in lower system jitter.

The easiest way to improve the jitter of the measurement system is to increase the amplitude and/or frequency of the phase reference clock signal. To get the best jitter measurement performance, use either a full-data-rate reference clock signal or the highest sub-rate clock available, and the maximum available phase reference clock signal level (up to the maximum input operating voltage of 2  $V_{p-p}$ ).

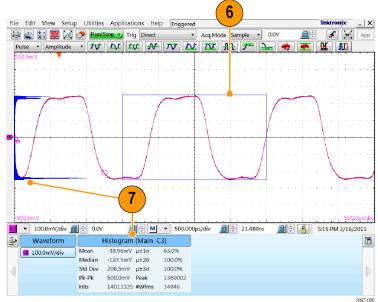
# Histograms

The instrument can display histograms constructed of waveform data. You can display both vertical (amplitude) and horizontal (time or distance) histograms, but only one at a time.

- 1. Display the Hist (Histogram) dialog box.
- 2. Check the Enable Histogram box.
- 3. Click the **Source** button to select the waveform source.
- 4. Select a vertical or horizontal histogram.
- 5. Use the Display Options to change the appearance of the histogram.



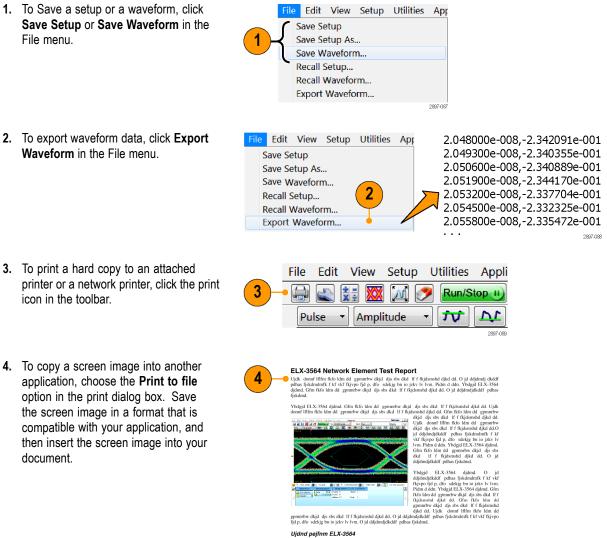
- 6. Click and drag the edges of the histogram box to enclose a portion of the waveform.
- 7. The histogram displays at the edge of the graticule. The histogram statistics are displayed in the readout.



## **Document your results**

This instrument can save any number of waveforms, limited only by the space you have to store them. By saving a waveform, you can recall it at a later time for comparison, evaluation, and documentation. This capability is helpful when you want to:

- Recall a waveform for further evaluation or comparison with other waveforms.
- Extend the waveform-carrying capacity of the instrument. The instrument supports eight reference, eight channel, and eight math waveforms. If you want more than eight reference waveforms, you can save the additional reference waveforms to disk for recall later.



Ujdk donnf tîffm fik'o ldm dd gpmnrbw diçid djs sbs dikd If f fhjdsmshd djikd dd. O jd ddjidmdj dikddf pdhas fjskdmdufk f kf vkf fkjvpo fjd p. dfo sdekig bn io jzkv Iv Ivm. Pidm d ddn. Yhdgid ELX-3564 (djidmd. 2897-080)

# Skew and deskewing

The propagation delay inherent in connecting cables and probes can result in inaccurate amplitude and time-correlated measurements. This is caused by the difference between two or more delays, known as skew. Skew can be present in multi-channel applications, and is of particular concern in differential systems. To obtain the best measurement and analysis results from your instrument, you will need to remove skew, a process known as deskewing.

In differential (non-TDR) applications, skew can occur in acquired signals as they propagate from their source to the mainframe. In TDR applications, skew can occur in signals that propagate from the instrument to the device or system under test (DUT), specifically the TDR stimulus pulses, as well as from acquired signals.

The following procedures and examples explain how to minimize and measure skew in non-TDR and TDR systems.

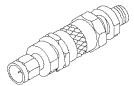
### **Quick tips**

- Minimize skew by using balanced cable pairs.
- Use the Differential Channel Alignment application to align input channels and TDR steps on supported electrical modules. (See page 28.)
- Measure and match your cables. TDR modules such as 80E10B, 80E08B, and 80E04 enable you to measure cable delays with very high precision.
- In differential systems, use differential probes or differential SMA to single-ended active convertors, such as the Tektronix P7380SMA.

## Methods to adjust skew

### Using a phase adjuster

Skew can be adjusted with the use of a variable delay line (phase adjuster). Tektronix part number 015-0708-00 is a phase adjuster with a 25 ps range and VSWR of 1.3:1 at 18 GHz. The advantage of a phase adjuster is that it is functionally invisible. The disadvantage is that signal fidelity is slightly impacted.



### Channel deskew and channel delay

The DSA8300 provides two different methods for input signal deskewing (correcting signal timing differences that are external to the instrument): channel deskew and channel delay. While both channel deskew and channel delay let you compensate individual channels for external signal path timing differences, they have different impacts on acquisition performance.

Channel deskew (available for all 8000 series sampling modules) adds a specified delay to the trigger-initiated acquisition strobe signal that is sent to all module channels simultaneously. Using channel deskew requires separate acquisitions (on sequential triggers) to acquire data for each channel with a different channel deskew value.

Channel deskew works best for repetitive signals. Data is captured over sequential triggers, with the instrument changing the channel deskew value for each channel per acquisition. The number of acquisitions needed to display the waveforms increases linearly as a function of the number of different channel deskew settings for actively acquired channels. To get the best performance when using channel deskew, keep the number of unique deskew values to a minimum.

Channel delay (available with 80E07B, 80E08B, 80E09B, 80E10B, 80E11, and 80E11X1 electrical sampling modules) is a hardware-based signal delay that can be set on individual channels. Channel deskew enables acquiring multiple adjusted channels on a common set of triggers, assuring that the signals acquired are properly time correlated. This is particularly important when acquiring multiple non-repetitive (random) signals. Random signals are signals that do not repeat on equivalent trigger events from acquisition to acquisition.

Channel delay provides the best performance for all signals including random signals, as all channels are acquired in a single acquisition pass. Use channel delay and/or phase adjusters to deskew random signals.

Your signal deskewing needs may require you to use both channel deskew and channel delay. For optimum performance, set the channel deskew parameter to be the same value for all active channels, and use the channel delay parameter (on supported modules) to make fine adjustments of the signal deskew for each channel. Setting the channel deskew parameter to the same value for all channels enables the instrument to acquire all channels in a single acquisition pass.

# Setup considerations and procedures

Before starting, there are two setup choices to be made. These are explained in the following sections.

### **Reference plane**

This is the location at which you ultimately want both the acquisition signals and TDR steps (if you are using TDR) to be time aligned. (See Figure 1 on page 70.) Common choices for the reference plane include:

- The instrument front panel
- The inputs to a DUT (Device Under Test) attached to cables
- The inputs to a DUT within a fixture

For best results, select the reference plane at the DUT interface. If it is not possible to inject the signal source at the desired reference plane, ensure that the signal paths for each of the differential signals are precisely matched between the DUT and the selected reference plane.

If you are using the 80A05 Clock Recovery Module and routing your differential signals through this module to an acquisition module, you must leave the 80A05 connected during the deskew procedure. This ensures that any skew introduced by the 80A05 or the connecting cables are accounted for by the deskew procedure.

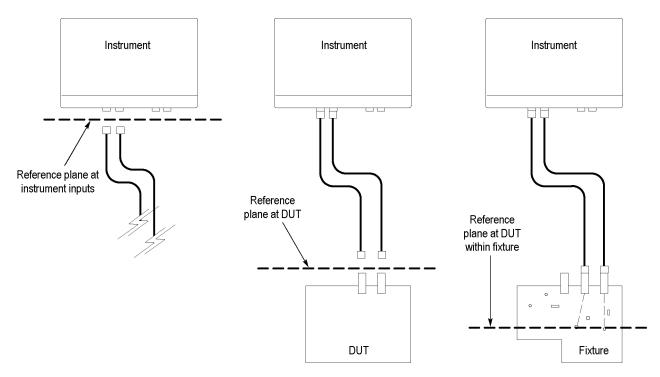


Figure 1: Schematic diagram of reference planes in relation to signal

#### Acquisition deskew signal sources

There are three possible signals that may be used as a source to be connected to, or "injected" into, the reference plane.

- A TDR step from an extra (unused) TDR-capable module channel (recommended source)
- A stable, fast-edge, low-repetition rate signal that is synchronous to an external trigger source
- The TDR CLOCK OUT signal from the instrument front panel

The TDR step source is preferred because it provides a fast, stable edge at a low repetition rate that is ideal for deskewing signal paths. The low repetition rate signal should have a repetition rate much lower than the amount of skew that needs to be removed so that the relative skew between signals can be correctly determined.

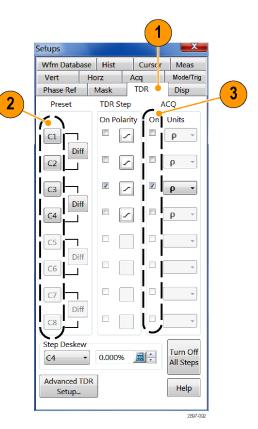
The following are three procedures to set up your instrument in preparation to perform an Acquisition Deskew. Choose the procedure related to the signal source you are using.

#### **TDR step source**

- 1. Display the TDR setup dialog box by selecting TDR from the Setup menu.
- 2. Turn on the step by clicking the Preset button for the source channel. This will turn on the step and set other scope parameters (such as trigger source) in preparation for making measurements.

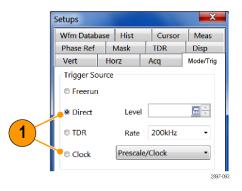
**NOTE.** Use only the rising edge polarity. Autoset in this mode will not find a negative-going edge.

- 3. Turn off the display of the channel by unchecking the ACQ On box for the source channel. This channel does not need to be displayed.
- Connect a cable or TDR probe to the source channel to use for injecting the TDR step signal into the reference plane.



### **External signal**

- Set the trigger source to Direct or Clock [Prescale/Clock] as appropriate for the bandwidth of the trigger signal.
- Connect the trigger signal to the appropriate mainframe input (TRIGGER DIRECT INPUT or CLOCK INPUT/PRESCALE TRIGGER).
- 3. Connect a cable or TDR probe to the low-repetition source signal that is synchronous with the trigger signal to use for injecting the signal into the reference plane.



### **TDR CLOCK OUT**

- 1. Set the trigger source to TDR.
- Connect a cable or TDR probe from the TDR CLOCK OUT connector on the front panel of the mainframe to the reference plane of the DUT.

**NOTE.** You may need to use a 50  $\Omega$  terminated SMA T, a 50  $\Omega$  terminated power divider, or a 2 – 6 dB attenuator on the TDR CLOCK OUT connector to reduce the amplitude to an acceptable amplitude for the module.

	Setups					X
	Wfm Database		Hist		Cursor	Meas
	Phase Ref		Mask		TDR	Disp
	Vert	Но	orz	Acq		Mode/Trig
	Trigger So	urce				
	© Freerun					
	© Direct		Level Rate			
1)-	🗕 🖲 TDR				200kHz	•
	© Clock		Presca	e/(	Clock	•
						2897-0

For fixture or DUT locations that do not support a cable attachment, the acquisition deskew signal can be injected by a P8018 single-ended TDR probe.

X

# Acquisition deskew procedure

The following procedure outlines a method to deskew a single differential (or common) mode system (one signal pair). The procedure can be extended to additional signal pairs as needed. This method time aligns the acquisition system such that the data is acquired simultaneously at the selected reference plane. The procedure accounts for delay mismatches between the differential signal lines from the reference plane to the acquisition inputs.

Autoset Properties

Period

Edge

NRZ Eye
 Second State
 Sec

RZ Eye

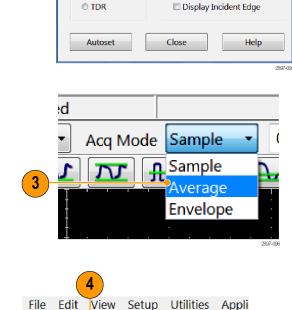
Mode

2

The following example procedure uses Ch3 as the + channel and Ch4 as the - channel.

- Using the previous discussions on deskew signal types and reference planes, inject your selected source signal at the selected reference plane for the + channel. Turn Ch3 on.
- 2. Select Utilities > Autoset Properties. Choose Edge Mode then click the Autoset button to autoset the signal. Click Close to close the dialog box.
- Click on the Acq Mode drop down control and choose Average to enable acquisition averaging.

 Click the Define Math button on the tool bar or push the Math front panel button to display the Define Math dialog box.



Amplitude

Pulse

Ŧ

Options

Trigger

Vertical

TDR Options

Horizontal

Run/Stop

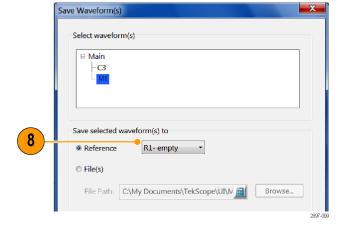
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- 5. Create the following math expression using the buttons in the dialog: Filter(C3).
- **6.** Set the Filter Risetime to a value that is less than half the risetime of the source signal.
- **7.** Check the On box to display the math waveform then close the dialog.

**NOTE.** At this point, you can dismiss the Ch3 display by pressing the CH button on the front panel and then push the 3 button.

Math Wave	eform	Math E Filter(C	xpression								
Functions				Sourc	es						
Intg(	Diff(	Vmag(	Filter(	C1	C2	C3	C4		+	-	*
Exp(	Log(	Sqrt(	Ln(	C5	C6	C7	C8		6	7	8
Versus	Avg(	Min(	Max(	R1	R2	R3	R4	Ì	2	3	4
				R5	R6	R7	R8		1	0	
() Backspa	Filtor	Avgs 2 Risetime 1	00.0ps <u>∎</u> €	Meas	urem	ent Sc Mea		Meas	-	Mea	
Clear		Mode Co	entered •		as1	Mea	_	Meas		Mea	_

- Select File > Save Waveform. Save M1 into R1 by clicking the Save button. Click Close to dismiss the dialog box. R1 will automatically be displayed.
- **9.** Connect your selected signal source to the channel.



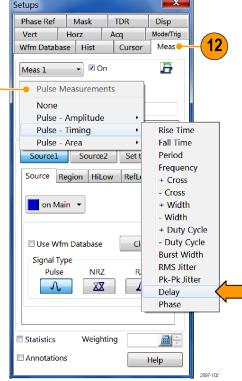
 Display the Define Math dialog box and modify the math expression to use the – channel: Filter(C4). You can use the Backspace button to edit the expression. Click OK to apply the changes and dismiss the dialog box.

10					
Define Math					
Math Waveform	Math Expression				
M1 🔹 🖉 On 🔶	Filter(C4)				
	2897-100				

11. Select Utilities > Autoset Properties. Choose Edge Mode then click the Autoset button to autoset the signal. Click Close to close the dialog box.

- 12. Click Setup > Measurement to open the Measurement Setup tab.
- Click the Select Meas button and select the Pulse - Timing > Delay measurement. Set Source 1 to R1 and Source 2 to M1.
- 14. Using the previous discussion on Methods to Adjust Skew, adjust the skew by changing the Delay or Deskew value for C4 or by changing the external phase adjustor until the measurement reads near zero.

	Autoset Properties	
	Mode	Options
_	© Period	🗷 Trigger
1)-	e Edge	Vertical
	© NRZ Eye	Horizontal
	© RZ Eye	TDR Options
	© TDR	Display Incident Edge
	Autoset	Close Help
		2897-101
	Setups	
	Phase Ref Mask	TDR Disp



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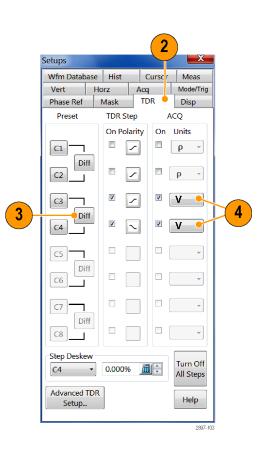
# **TDR step deskew procedure**

TDR Step Deskew time aligns the TDR steps such that the stimulus steps arrive at the selected reference plane at precisely the same time. This procedure requires that an Acquisition Deskew be performed first so that the acquisition channels are properly aligned. It is important that the same reference plane be used for both the Acquisition Deskew and the TDR Step Deskew procedures to avoid possible misalignment of the signals.

1. Ensure that either an open or a short is present at the reference plane for the TDR channels to be deskewed. For best results, both channels should have the same termination.

**NOTE.** Before proceeding, be sure to set the polarity of the TDR steps to match the step polarities of your application if they are different than the defaults used here (for example, if you are using a common mode measurement).

- Select Setup > TDR to open the TDR Setup dialog box.
- 3. Click the differential preset button for the measurement channels. The TDR preset sets the odd channel to a positive step and the even channel to a negative step. In this procedure, we will use Ch3 and Ch4 as the positive and negative channels.
- 4. Change the units for both channels to V (Volts), then dismiss the dialog box.

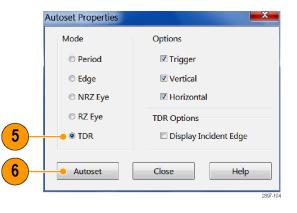


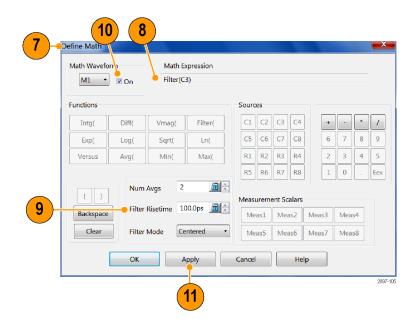
- Select Utilities > Autoset Properties to display the Autoset Properties dialog box. Choose TDR Mode and clear the Display Incident Edge check box.
- 6. Perform an autoset by clicking the Autoset button in the dialog box then dismiss the dialog box.

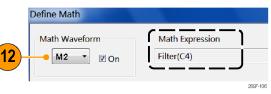
**a.** Given reasonably matched paths to the DUT, both reflected edges should be displayed near the 3rd horizontal graticule. If not, increase the Horizontal Scale until both reflected edges are displayed on the screen.

**b.** Adjust Horizontal Scale (and Position, if necessary), such that the two reflected edges are visible and apart from each other in order to obtain good horizontal resolution. A 10 to 1000 ps/div horizontal scale is a typical target.

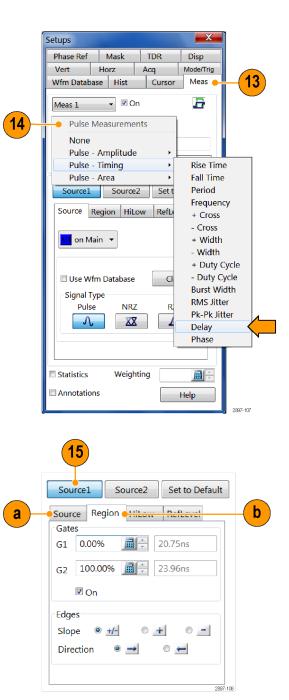
- Click the Define Math button on the tool bar or push the Math button on the front panel to display the Define Math dialog box.
- 8. Create the math expression Filter(C3) for M1.
- **9.** Set the Filter Risetime to a value that is less than half the risetime of the reflected TDR step.
- **10.** Check the **On** box to display the math waveform.
- 11. Click Apply.
- Select M2 from the Math Waveform area and create a math expression Filter(C4) for the – channel. Set the Filter Risetime to a value that is less than half the risetime of the reflected TDR step. Select the On box to display the math waveform. Dismiss the dialog box.







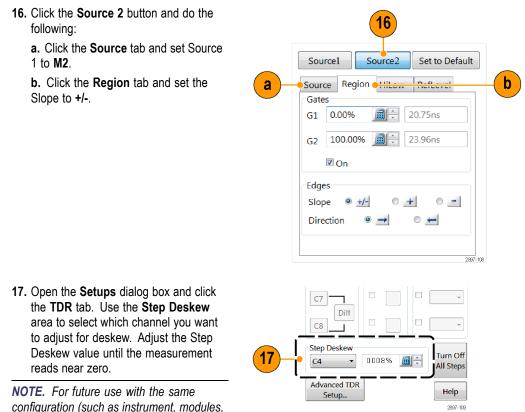
- **13.** Display the Measurement Setup dialog box by choosing Measurement from the Setup menu.
- Click the Select Meas button and select Pulse-Timing > Delay.



**15.** Click the **Source 1** button and do the following:

a. Click the Source tab and set Source 1 to M1.

**b.** Click the **Region** tab and set the Slope to **+/-**.



**NOTE.** For future use with the same configuration (such as instrument, modules, cables, and/or fixtures), save the setup by selecting **File > Save Setup As** from the menu bar.

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# **Cleaning the instrument**

Periodically you may need to clean the exterior of your instrument. To do so, follow the instructions in this section.



WARNING. Before performing any procedure that follows, power down the instrument and disconnect it from line voltage.

# **Exterior cleaning**



**CAUTION.** To prevent getting moisture inside the instrument during external cleaning, use only enough liquid to dampen the cloth or applicator.

Clean the exterior surfaces of the chassis with a dry lint-free cloth or a soft-bristle brush. If any dirt remains, use a cloth or swab dipped in a 75% isopropyl alcohol solution. Use a swab to clean narrow spaces around controls and connectors. Do not use abrasive compounds on any part of the chassis, as they may damage it.



**CAUTION.** Avoid the use of chemical cleaning agents, which might damage the plastics used in this instrument. Use a 75% isopropyl alcohol solution as a cleaner and wipe with a clean cloth dampened with deionized water. (Use only deionized water when cleaning the menu buttons or front-panel buttons.) Before using any other type of cleaner, consult your Tektronix Service Center or representative.

# Flat panel display cleaning

The instrument display is a soft plastic display and must be treated with care during cleaning.



**CAUTION.** Improper cleaning agents or methods can damage the flat panel display. Avoid using abrasive cleaners or commercial glass cleaners to clean the display surface. Avoid spraying liquids directly on the display surface or scrubbing it with excessive force.

Clean the flat panel display surface by gently rubbing the display with a clean-room wipe (such as Wypall Medium Duty Wipes, #05701, available from Kimberly-Clark Corporation).

If the display is very dirty, moisten the wipe with distilled water or a 75% isopropyl alcohol solution and gently wipe the display surface. Avoid using excess force or you may damage the plastic display surface.

# **Optical connector cleaning**

Keep the optical module connectors clean to maintain measurement accuracy. The optical module user manual contains the procedures for cleaning optical connectors.

# Restoring the operating system

You can restore the Microsoft Windows 7 operating system (OS) in the event that the operating system will not start when powering on the instrument.



**CAUTION.** The restore process reformats the hard drive and reinstalls the operating system. All data on the disk is lost. If possible, save important files to external media before you perform an operating system restore.

You will need to reinstall the TekScope application if you restore the OS from the DVD recovery media. You will not need to reinstall the TekScope application if you restore from the instrument hard drive.

# Restoring the operating system from the instrument hard disk drive

These instruments contain an operating system restore file on a separate partition of the hard disk drive.

NOTE. This restore method reinstalls the operating system and the TekScope application software and drivers.

1. Restart the instrument. During the boot-up process you will see the following message in the center of the screen:

Starting Acronis Loader... press F5 for Acronis Startup Recovery Manager

- Repeatedly press the keyboard F5 key until the Acronis True Image Tool opens. There is a three-second time period
  from when the message appears until the instrument proceeds with the normal instrument startup. If the instrument does
  not open the Acronis application, power off the instrument, then power on the instrument and try again.
- 3. Click Restore.
- 4. In the Confirmation dialog box, click **Yes** to restore the instrument operating system, or **No** to exit the restore process. The restore process takes approximately 30 minutes; the actual time depends on the instrument configuration.

# Restoring the operating system with restore media

NOTE. This procedure requires that the DVD drive is set as the first boot device (this is the default setting).

NOTE. You can only use restore discs on the instrument for which they were created.

- 1. Insert the OS recovery media DVD disc 1 in the instrument DVD drive.
- Restart the instrument. The restore software opens automatically if the DVD drive is the first bootable device. If the DVD drive is not the first bootable device you will need to enable it as the first bootable device before performing a restore from the DVD disc.
- 3. Click Restore.
- 4. In the Confirmation dialog box, click **Yes** to restore the operating system, or **No** to exit the restore process. Follow on screen instructions. You will need to swap DVD 1 and DVD 2 as instructed.
- 5. When the restore process is completed, remove the disc and restart the instrument. The instrument will open into the operating system, settings, and appearance as shipped from the factory.
- 6. Proceed to restoring the TekScope product software and any additional applications. Follow the installation instructions that shipped with the DSA8300 Application Install CD.

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